

|                                                                                   |                                                                                                      |                                            |                                               |                                                   |
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| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                                   | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/> L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW<br/> 2503A-RFK120LW</b> |

## APPENDIX D: PROBE & DIPOLE CALIBRATION DATA

|                                                                                   |                                                                                                              |                                                    |                                            |                                                       |
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**Calibration Laboratory of  
 Schmid & Partner  
 Engineering AG**  
 Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst  
 C Service suisse d'étalonnage  
 S Servizio svizzero di taratura  
 S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
 The Swiss Accreditation Service is one of the signatories to the EA  
 Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **RTS (RIM Testing Services)**

Certificate No: **ES3-3225\_Jan12**

## CALIBRATION CERTIFICATE

Object **ES3DV3 + SN:3225**

Calibration procedure(s) **QA CAL-01.v8, QA CAL-23.v4, QA CAL-25.v4  
 Calibration procedure for dosimetric E-field probes**

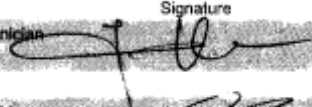
Calibration date: **January 11, 2012**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature ( $22 \pm 3$ )°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards          | ID              | Cal Date (Certificate No.)        | Scheduled Calibration  |
|----------------------------|-----------------|-----------------------------------|------------------------|
| Power meter E4419B         | GB41293874      | 31-Mar-11 (No. 217-01372)         | Apr-12                 |
| Power sensor E4412A        | MY41498087      | 31-Mar-11 (No. 217-01372)         | Apr-12                 |
| Reference 3 dB Attenuator  | SN: S5054 (3c)  | 29-Mar-11 (No. 217-01369)         | Apr-12                 |
| Reference 20 dB Attenuator | SN: S5086 (20b) | 29-Mar-11 (No. 217-01367)         | Apr-12                 |
| Reference 30 dB Attenuator | SN: S5129 (30b) | 29-Mar-11 (No. 217-01370)         | Apr-12                 |
| Reference Probe ES3DV2     | SN: 3013        | 29-Dec-11 (No. ES3-3013_Dec11)    | Dec-12                 |
| DAE4                       | SN: 654         | 3-May-11 (No. DAE4-654_May11)     | May-12                 |
| Secondary Standards        | ID              | Check Date (in house)             | Scheduled Check        |
| RF generator HP 8648C      | US3642U01700    | 4-Aug-99 (in house check Apr-11)  | In house check: Apr-13 |
| Network Analyzer HP 8753E  | US37390585      | 18-Oct-01 (in house check Oct-11) | In house check: Oct-12 |

|                                                                                                                                             |                               |                                          |                                                                                                    |
|---------------------------------------------------------------------------------------------------------------------------------------------|-------------------------------|------------------------------------------|----------------------------------------------------------------------------------------------------|
| Calibrated by:                                                                                                                              | Name<br><b>Jeton Kastrati</b> | Function<br><b>Laboratory Technician</b> | Signature<br>  |
| Approved by:                                                                                                                                | Name<br><b>Katja Pokovic</b>  | Function<br><b>Technical Manager</b>     | Signature<br> |
| Issued: January 12, 2012<br>This calibration certificate shall not be reproduced except in full without written approval of the laboratory. |                               |                                          |                                                                                                    |

Certificate No: ES3-3225\_Jan12

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**S** Schweizerischer Kalibrierdienst  
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**S** Swiss Calibration Service

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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

#### Glossary:

|                          |                                                                                                                                                         |
|--------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------|
| TSL                      | tissue simulating liquid                                                                                                                                |
| NORM <sub>x,y,z</sub>    | sensitivity in free space                                                                                                                               |
| ConvF                    | sensitivity in TSL / NORM <sub>x,y,z</sub>                                                                                                              |
| DCP                      | diode compression point                                                                                                                                 |
| CF                       | crest factor (1/duty_cycle) of the RF signal                                                                                                            |
| A, B, C                  | modulation dependent linearization parameters                                                                                                           |
| Polarization $\phi$      | $\phi$ rotation around probe axis                                                                                                                       |
| Polarization $\vartheta$ | $\vartheta$ rotation around an axis that is in the plane normal to probe axis (at measurement center),<br>i.e., $\vartheta = 0$ is normal to probe axis |

#### Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

#### Methods Applied and Interpretation of Parameters:

- NORM<sub>x,y,z</sub>**: Assessed for E-field polarization  $\vartheta = 0$  ( $f \leq 900$  MHz in TEM-cell;  $f > 1800$  MHz: R22 waveguide). NORM<sub>x,y,z</sub> are only intermediate values, i.e., the uncertainties of NORM<sub>x,y,z</sub> does not affect the E<sup>2</sup>-field uncertainty inside TSL (see below ConvF).
- NORM(f)<sub>x,y,z</sub>** = NORM<sub>x,y,z</sub> \* frequency\_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP<sub>x,y,z</sub>**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- A<sub>x,y,z</sub>; B<sub>x,y,z</sub>; C<sub>x,y,z</sub>; VR<sub>x,y,z</sub>**: A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for  $f \leq 800$  MHz) and inside waveguide using analytical field distributions based on power measurements for  $f > 800$  MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM<sub>x,y,z</sub> \* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from  $\pm 50$  MHz to  $\pm 100$  MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
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ES3DV3 – SN:3225

January 11, 2012

# Probe ES3DV3

## SN:3225

Manufactured: September 1, 2009  
Calibrated: January 11, 2012

Calibrated for DASY/EASY Systems  
(Note: non-compatible with DASY2 system!)

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
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ES3DV3– SN:3225

January 11, 2012

## DASY/EASY - Parameters of Probe: ES3DV3 - SN:3225

### Basic Calibration Parameters

|                                                           | Sensor X | Sensor Y | Sensor Z | Unc (k=2) |
|-----------------------------------------------------------|----------|----------|----------|-----------|
| Norm ( $\mu\text{V}/(\text{V}/\text{m})^2$ ) <sup>A</sup> | 1.26     | 1.20     | 1.30     | ± 10.1 %  |
| DCP (mV) <sup>B</sup>                                     | 101.2    | 100.8    | 101.2    |           |

### Modulation Calibration Parameters

| UID   | Communication System Name | PAR  |   | A<br>dB | B<br>dB | C<br>dB | VR<br>mV | Unc <sup>C</sup><br>(k=2) |
|-------|---------------------------|------|---|---------|---------|---------|----------|---------------------------|
| 10000 | CW                        | 0.00 | X | 0.00    | 0.00    | 1.00    | 107.7    | ±1.7 %                    |
|       |                           |      | Y | 0.00    | 0.00    | 1.00    | 113.4    |                           |
|       |                           |      | Z | 0.00    | 0.00    | 1.00    | 110.4    |                           |

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

<sup>A</sup> The uncertainties of NormX,Y,Z do not affect the E<sup>2</sup>-field uncertainty inside TSL (see Pages 5 and 6).

<sup>B</sup> Numerical linearization parameter: uncertainty not required.

<sup>C</sup> Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
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ES3DV3- SN:3225

January 11, 2012

## DASY/EASY - Parameters of Probe: ES3DV3 - SN:3225

### Calibration Parameter Determined in Head Tissue Simulating Media

| f (MHz) <sup>C</sup> | Relative Permittivity <sup>F</sup> | Conductivity (S/m) <sup>F</sup> | ConvF X | ConvF Y | ConvF Z | Alpha | Depth (mm) | Unct. (k=2) |
|----------------------|------------------------------------|---------------------------------|---------|---------|---------|-------|------------|-------------|
| 750                  | 41.9                               | 0.89                            | 6.42    | 6.42    | 6.42    | 0.27  | 2.04       | ± 12.0 %    |
| 900                  | 41.5                               | 0.97                            | 6.06    | 6.06    | 6.06    | 0.35  | 1.74       | ± 12.0 %    |
| 1810                 | 40.0                               | 1.40                            | 5.23    | 5.23    | 5.23    | 0.73  | 1.21       | ± 12.0 %    |
| 1950                 | 40.0                               | 1.40                            | 4.98    | 4.98    | 4.98    | 0.58  | 1.41       | ± 12.0 %    |
| 2450                 | 39.2                               | 1.80                            | 4.50    | 4.50    | 4.50    | 0.79  | 1.26       | ± 12.0 %    |
| 2600                 | 39.0                               | 1.96                            | 4.32    | 4.32    | 4.32    | 0.77  | 1.32       | ± 12.0 %    |

<sup>C</sup> Frequency validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ± 50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

<sup>F</sup> At frequencies below 3 GHz, the validity of tissue parameters ( $\epsilon$  and  $\sigma$ ) can be relaxed to ± 10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters ( $\epsilon$  and  $\sigma$ ) is restricted to ± 5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

|                                                                                   |                                                                                                      |                                            |                                               |                                                   |
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ES3DV3– SN:3225

January 11, 2012

## DASY/EASY - Parameters of Probe: ES3DV3 - SN:3225

### Calibration Parameter Determined in Body Tissue Simulating Media

| f (MHz) <sup>c</sup> | Relative Permittivity <sup>f</sup> | Conductivity (S/m) <sup>f</sup> | ConvF X | ConvF Y | ConvF Z | Alpha | Depth (mm) | Unct. (k=2) |
|----------------------|------------------------------------|---------------------------------|---------|---------|---------|-------|------------|-------------|
| 750                  | 55.5                               | 0.96                            | 6.27    | 6.27    | 6.27    | 0.36  | 1.74       | ± 12.0 %    |
| 900                  | 55.0                               | 1.05                            | 6.07    | 6.07    | 6.07    | 0.29  | 2.02       | ± 12.0 %    |
| 1810                 | 53.3                               | 1.52                            | 4.92    | 4.92    | 4.92    | 0.50  | 1.57       | ± 12.0 %    |
| 1950                 | 53.3                               | 1.52                            | 4.87    | 4.87    | 4.87    | 0.59  | 1.49       | ± 12.0 %    |
| 2450                 | 52.7                               | 1.95                            | 4.30    | 4.30    | 4.30    | 0.68  | 1.16       | ± 12.0 %    |
| 2600                 | 52.5                               | 2.16                            | 4.12    | 4.12    | 4.12    | 0.80  | 0.99       | ± 12.0 %    |

<sup>c</sup> Frequency validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ± 50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

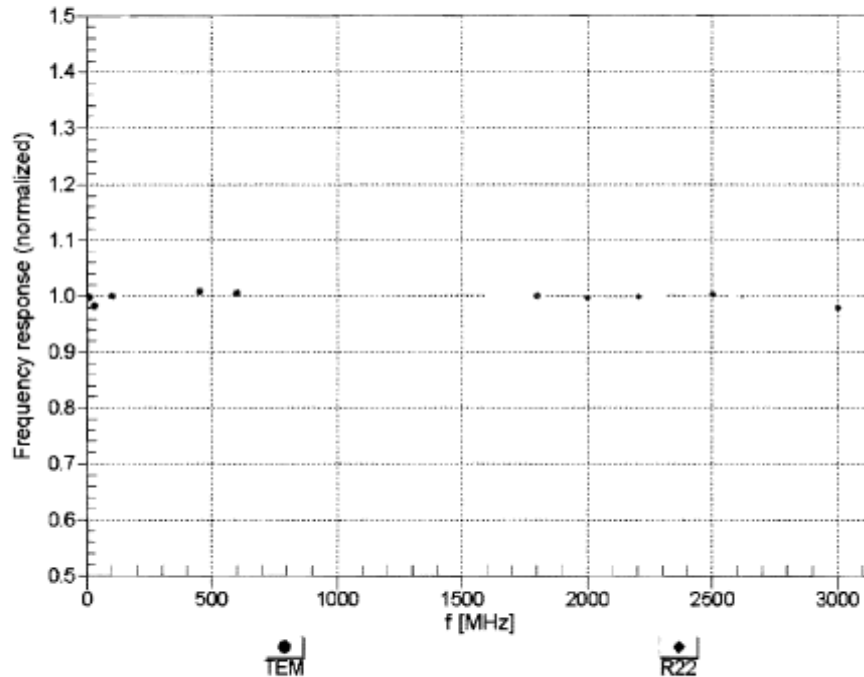
<sup>f</sup> At frequencies below 3 GHz, the validity of tissue parameters ( $\epsilon$  and  $\sigma$ ) can be relaxed to ± 10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters ( $\epsilon$  and  $\sigma$ ) is restricted to ± 5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

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ES3DV3– SN:3225

January 11, 2012

## Frequency Response of E-Field (TEM-Cell: ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field:  $\pm 6.3\%$  (k=2)

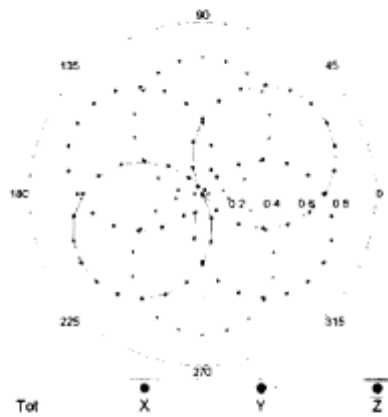
|                                                                                   |                                                                                                 |                                            |                                              |                                                  |
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ES3DV3– SN:3225

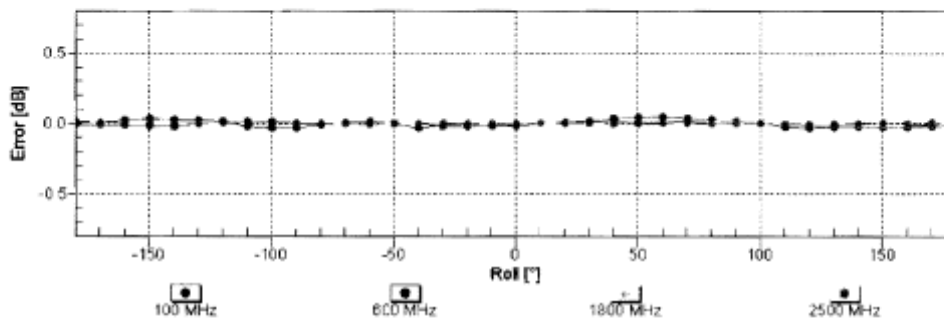
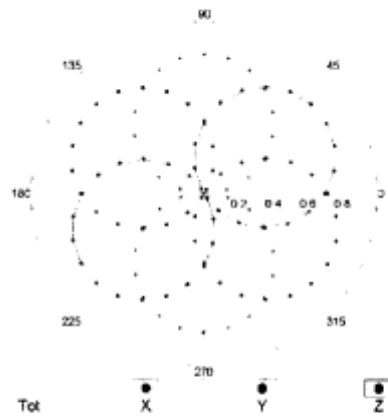
January 11, 2012

## Receiving Pattern ( $\phi$ ), $\theta = 0^\circ$

f=600 MHz,TEM



f=1800 MHz,R22



Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  (k=2)

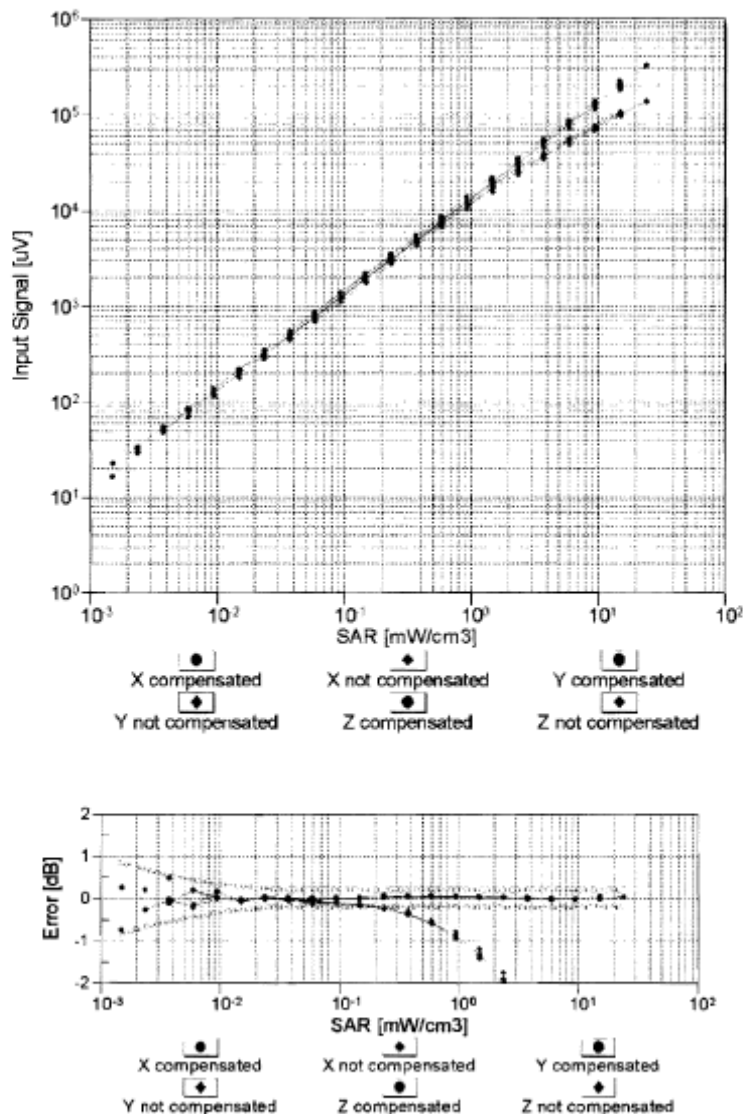
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ES3DV3– SN:3225

January 11, 2012

### Dynamic Range $f(\text{SAR}_{\text{head}})$ (TEM cell , $f = 900 \text{ MHz}$ )



Uncertainty of Linearity Assessment:  $\pm 0.6\%$  ( $k=2$ )

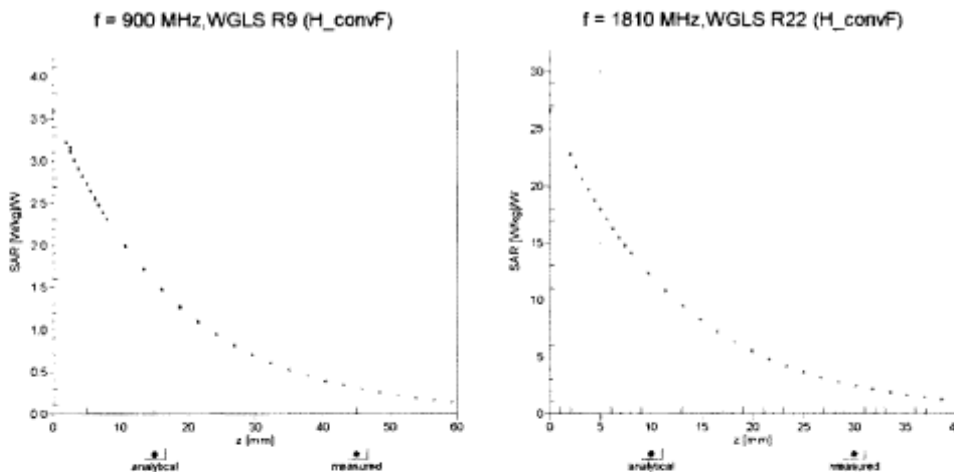
|                                                                                   |                                                                                                      |                                            |                                               |                                                   |
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ES3DV3– SN:3225

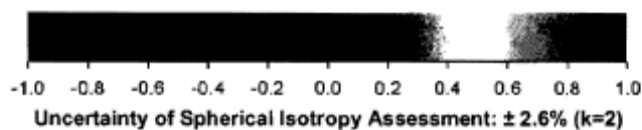
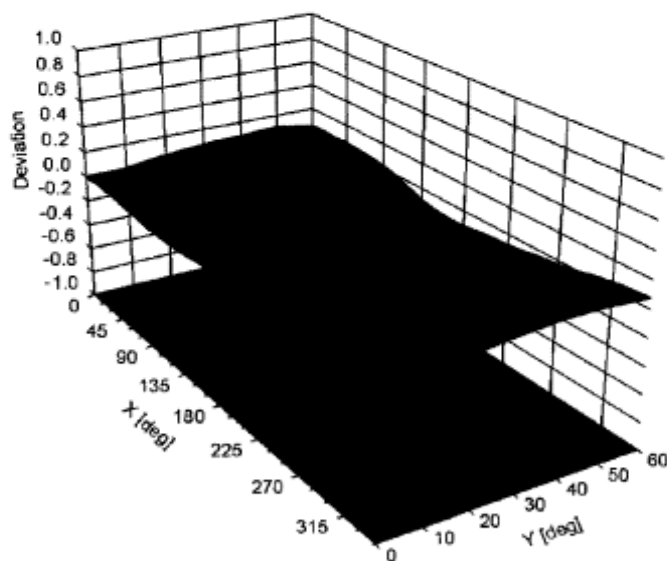
January 11, 2012

## Conversion Factor Assessment



## Deviation from Isotropy in Liquid

Error ( $\phi$ ,  $\theta$ ),  $f = 900$  MHz



|                                                                                   |                                                                                                      |                                            |                                               |                                                   |
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| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                                   | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/> L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW<br/> 2503A-RFK120LW</b> |

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
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| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW</b><br><b>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW</b><br><b>2503A-RFK120LW</b> |

ES3DV3– SN:3225

January 11, 2012

## DASY/EASY - Parameters of Probe: ES3DV3 - SN:3225

### Other Probe Parameters

|                                               |                |
|-----------------------------------------------|----------------|
| Sensor Arrangement                            | Triangular     |
| Connector Angle (°)                           | Not applicable |
| Mechanical Surface Detection Mode             | enabled        |
| Optical Surface Detection Mode                | disabled       |
| Probe Overall Length                          | 337 mm         |
| Probe Body Diameter                           | 10 mm          |
| Tip Length                                    | 10 mm          |
| Tip Diameter                                  | 4 mm           |
| Probe Tip to Sensor X Calibration Point       | 2 mm           |
| Probe Tip to Sensor Y Calibration Point       | 2 mm           |
| Probe Tip to Sensor Z Calibration Point       | 2 mm           |
| Recommended Measurement Distance from Surface | 3 mm           |

|                                                                                   |                                                                                                      |                                            |                                               |                                                   |
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| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                                   | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/> L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW<br/> 2503A-RFK120LW</b> |

|                                                                                   |                                                                                                 |                                                    |                                            |                                              |
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|                                                                                   | Author Data<br><b>Andrew Becker</b>                                                             | Dates of Test<br><b>June 04 – October 29, 2012</b> | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/>L6ARFK120LW</b> |

**Calibration Laboratory of**  
**Schmid & Partner**  
**Engineering AG**  
 Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
**C** Service suisse d'étalonnage  
**S** Servizio svizzero di taratura  
**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
 The Swiss Accreditation Service is one of the signatories to the EA  
 Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

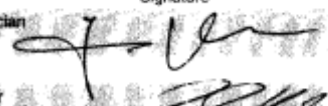
Client **RTS (RIM Testing Services)**

Certificate No: **EX3-3592\_Nov11**

## CALIBRATION CERTIFICATE

|                                                                                                                                                                                                                                                                               |                                                                                                                       |
|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------|
| Object                                                                                                                                                                                                                                                                        | <b>EX3DV4 - SN:3592</b>                                                                                               |
| Calibration procedure(s)                                                                                                                                                                                                                                                      | <b>QA CAL-01.v8, QA CAL-14.v3, QA CAL-23.v4, QA CAL-25.v4<br/>Calibration procedure for dosimetric E-field probes</b> |
| Calibration date:                                                                                                                                                                                                                                                             | <b>November 16, 2011</b>                                                                                              |
| This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).<br>The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. |                                                                                                                       |
| All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.                                                                                                                                                |                                                                                                                       |
| Calibration Equipment used (M&TE critical for calibration)                                                                                                                                                                                                                    |                                                                                                                       |

| Primary Standards          | ID              | Cal Date (Certificate No.)        | Scheduled Calibration  |
|----------------------------|-----------------|-----------------------------------|------------------------|
| Power meter E4419B         | GB41293874      | 31-Mar-11 (No. 217-01372)         | Apr-12                 |
| Power sensor E4412A        | MY41498087      | 31-Mar-11 (No. 217-01372)         | Apr-12                 |
| Reference 3 dB Attenuator  | SN: S5054 (3c)  | 29-Mar-11 (No. 217-01369)         | Apr-12                 |
| Reference 20 dB Attenuator | SN: S5086 (20b) | 29-Mar-11 (No. 217-01367)         | Apr-12                 |
| Reference 30 dB Attenuator | SN: S5129 (30b) | 29-Mar-11 (No. 217-01370)         | Apr-12                 |
| Reference Probe ES3DV2     | SN: 3013        | 29-Dec-10 (No. ES3-3013_Dec10)    | Dec-11                 |
| DAE4                       | SN: 654         | 3-May-11 (No. DAE4-654_May11)     | May-12                 |
| Secondary Standards        | ID              | Check Date (in house)             | Scheduled Check        |
| RF generator HP 8648C      | US3642U01700    | 4-Aug-99 (in house check Apr-11)  | In house check: Apr-13 |
| Network Analyzer HP 8753E  | US37390585      | 18-Oct-01 (in house check Oct-11) | In house check: Oct-12 |

|                                                                                                                                              |                               |                                          |                                                                                                   |
|----------------------------------------------------------------------------------------------------------------------------------------------|-------------------------------|------------------------------------------|---------------------------------------------------------------------------------------------------|
| Calibrated by:                                                                                                                               | Name<br><b>Jeton Kastrati</b> | Function<br><b>Laboratory Technician</b> | Signature<br> |
| Approved by:                                                                                                                                 | Name<br><b>Katja Pokovic</b>  | Technical Manager                        |              |
| Issued: November 16, 2011<br>This calibration certificate shall not be reproduced except in full without written approval of the laboratory. |                               |                                          |                                                                                                   |

Certificate No: EX3-3592\_Nov11

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|                                                                                   |                                                                                                 |                                            |                                              |                                                  |
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**Calibration Laboratory of**  
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**S** Schweizerischer Kalibrierdienst  
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Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

#### Glossary:

|                          |                                                                                                                                                      |
|--------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------|
| TSL                      | tissue simulating liquid                                                                                                                             |
| NORM <sub>x,y,z</sub>    | sensitivity in free space                                                                                                                            |
| ConvF                    | sensitivity in TSL / NORM <sub>x,y,z</sub>                                                                                                           |
| DCP                      | diode compression point                                                                                                                              |
| CF                       | crest factor (1/duty_cycle) of the RF signal                                                                                                         |
| A, B, C                  | modulation dependent linearization parameters                                                                                                        |
| Polarization $\varphi$   | $\varphi$ rotation around probe axis                                                                                                                 |
| Polarization $\vartheta$ | $\vartheta$ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis |

#### Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

#### Methods Applied and Interpretation of Parameters:

- NORM<sub>x,y,z</sub>**: Assessed for E-field polarization  $\vartheta = 0$  ( $f \leq 900$  MHz in TEM-cell;  $f > 1800$  MHz: R22 waveguide). NORM<sub>x,y,z</sub> are only intermediate values, i.e., the uncertainties of NORM<sub>x,y,z</sub> does not affect the E<sup>2</sup>-field uncertainty inside TSL (see below ConvF).
- NORM(f)<sub>x,y,z</sub> = NORM<sub>x,y,z</sub> \* frequency\_response** (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP<sub>x,y,z</sub>**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- A<sub>x,y,z</sub>; B<sub>x,y,z</sub>; C<sub>x,y,z</sub>; VR<sub>x,y,z</sub>**: A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for  $f \leq 800$  MHz) and inside waveguide using analytical field distributions based on power measurements for  $f > 800$  MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM<sub>x,y,z</sub> \* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from  $\pm 50$  MHz to  $\pm 100$  MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

|                                                                                   |                                                    |                                                                                                 |                                                    |                                                        |
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| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b> | Test Report No<br><b>RTS-6012-1208-35B</b>                                                      | FCC ID:<br><b>L6ARFF90LW</b><br><b>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW</b><br><b>2503A-RFK120LW</b> |

EX3DV4 – SN:3592

November 16, 2011

# Probe EX3DV4

## SN:3592

Manufactured: September 18, 2006  
Calibrated: November 16, 2011

Calibrated for DASY/EASY Systems  
(Note: non-compatible with DASY2 system!)

|                                                                                  |                                                                              |                                     |                                      |                                          |
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|                                                                                  | Appendix D for the BlackBerry® Smartphone Model RFF91LW, RFK121LW SAR Report |                                     |                                      | 22(78)                                   |
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EX3DV4– SN:3592

November 16, 2011

## DASY/EASY - Parameters of Probe: EX3DV4 - SN:3592

### Basic Calibration Parameters

|                                                           | Sensor X | Sensor Y | Sensor Z | Unc (k=2) |
|-----------------------------------------------------------|----------|----------|----------|-----------|
| Norm ( $\mu\text{V}/(\text{V}/\text{m})^2$ ) <sup>A</sup> | 0.48     | 0.48     | 0.41     | ± 10.1 %  |
| DCP (mV) <sup>B</sup>                                     | 95.2     | 95.3     | 98.7     |           |

### Modulation Calibration Parameters

| UID   | Communication System Name | PAR  |   | A<br>dB | B<br>dB | C<br>dB | VR<br>mV | Unc <sup>C</sup><br>(k=2) |
|-------|---------------------------|------|---|---------|---------|---------|----------|---------------------------|
| 10000 | CW                        | 0.00 | X | 0.00    | 0.00    | 1.00    | 117.9    | ±2.7 %                    |
|       |                           |      | Y | 0.00    | 0.00    | 1.00    | 101.0    |                           |
|       |                           |      | Z | 0.00    | 0.00    | 1.00    | 104.3    |                           |

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

<sup>A</sup> The uncertainties of NormX,Y,Z do not affect the E<sup>2</sup>-field uncertainty inside TSL (see Pages 5 and 6).

<sup>B</sup> Numerical linearization parameter: uncertainty not required.

<sup>C</sup> Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

|                                                                                   |                                                    |                                                                                                 |                                                    |                                                        |
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EX3DV4– SN:3592

November 16, 2011

## DASY/EASY - Parameters of Probe: EX3DV4 - SN:3592

### Calibration Parameter Determined in Head Tissue Simulating Media

| f (MHz) <sup>c</sup> | Relative Permittivity <sup>f</sup> | Conductivity (S/m) <sup>f</sup> | ConvF X | ConvF Y | ConvF Z | Alpha | Depth (mm) | Unct. (k=2) |
|----------------------|------------------------------------|---------------------------------|---------|---------|---------|-------|------------|-------------|
| 5200                 | 36.0                               | 4.66                            | 4.89    | 4.89    | 4.89    | 0.33  | 1.80       | ± 13.1 %    |
| 5500                 | 35.6                               | 4.96                            | 4.38    | 4.38    | 4.38    | 0.38  | 1.80       | ± 13.1 %    |
| 5800                 | 35.3                               | 5.27                            | 4.17    | 4.17    | 4.17    | 0.40  | 1.80       | ± 13.1 %    |

<sup>c</sup> Frequency validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ± 50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

<sup>f</sup> At frequencies below 3 GHz, the validity of tissue parameters ( $\epsilon$  and  $\sigma$ ) can be relaxed to ± 10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters ( $\epsilon$  and  $\sigma$ ) is restricted to ± 5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

|                                                                                   |                                                    |                                                                                                 |                                                    |                                                        |
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EX3DV4– SN:3592

November 16, 2011

## DASY/EASY - Parameters of Probe: EX3DV4 - SN:3592

### Calibration Parameter Determined in Body Tissue Simulating Media

| f (MHz) <sup>c</sup> | Relative Permittivity <sup>f</sup> | Conductivity (S/m) <sup>f</sup> | ConvF X | ConvF Y | ConvF Z | Alpha | Depth (mm) | Unct. (k=2) |
|----------------------|------------------------------------|---------------------------------|---------|---------|---------|-------|------------|-------------|
| 5200                 | 49.0                               | 5.30                            | 4.05    | 4.05    | 4.05    | 0.50  | 1.90       | ± 13.1 %    |
| 5500                 | 48.6                               | 5.65                            | 3.62    | 3.62    | 3.62    | 0.55  | 1.90       | ± 13.1 %    |
| 5800                 | 48.2                               | 6.00                            | 3.54    | 3.54    | 3.54    | 0.60  | 1.90       | ± 13.1 %    |

<sup>c</sup> Frequency validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ± 50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

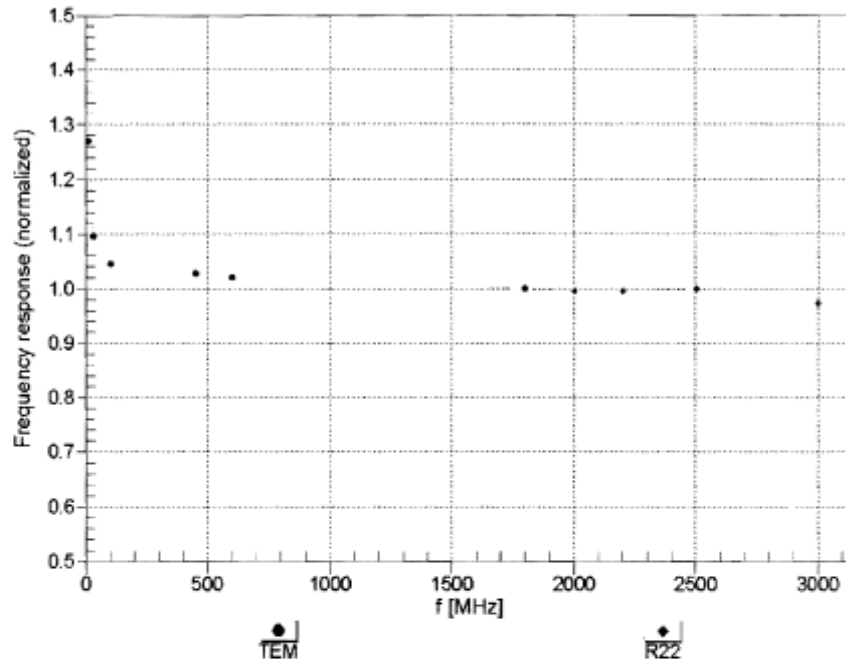
<sup>f</sup> At frequencies below 3 GHz, the validity of tissue parameters ( $\epsilon$  and  $\sigma$ ) can be relaxed to ± 10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters ( $\epsilon$  and  $\sigma$ ) is restricted to ± 5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

|                                                                                   |                                                                                                 |                                            |                                              |                                                  |
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EX3DV4– SN:3592

November 16, 2011

## Frequency Response of E-Field (TEM-Cell:ifi110 EXX, Waveguide: R22)



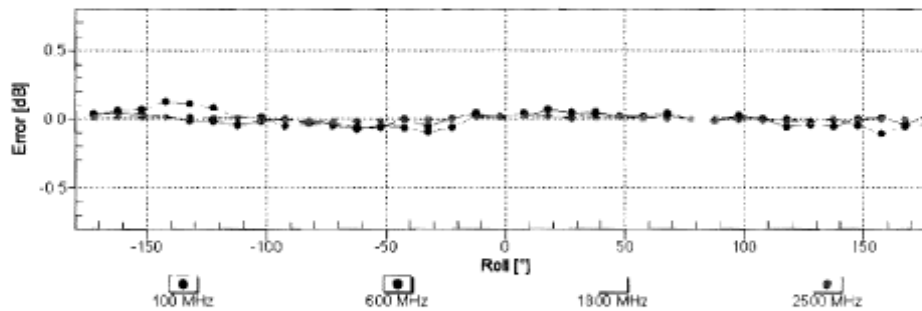
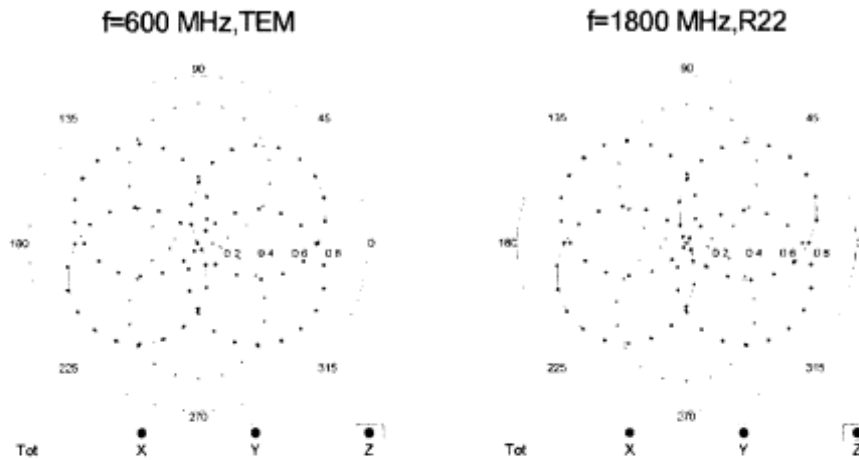
Uncertainty of Frequency Response of E-field:  $\pm 6.3\%$  ( $k=2$ )

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
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EX3DV4– SN:3592

November 16, 2011

## Receiving Pattern ( $\phi$ ), $\theta = 0^\circ$



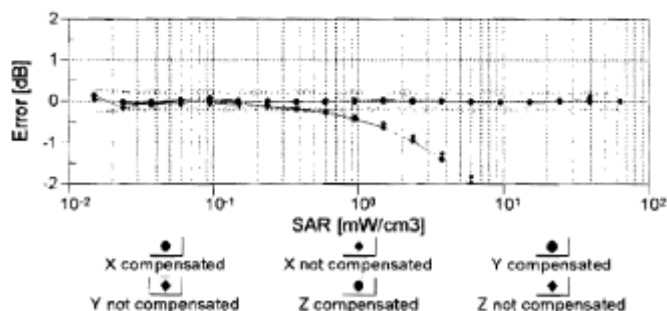
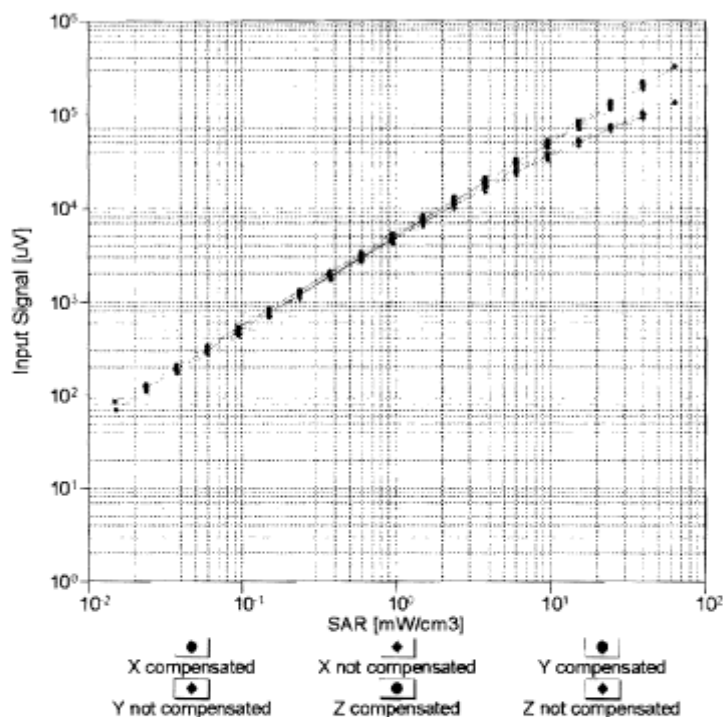
Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  ( $k=2$ )

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
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|  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW, RFK121LW SAR Report</b> |                                            |                                                    | Page<br><b>27(78)</b>                                  |
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EX3DV4– SN:3592

November 16, 2011

### Dynamic Range $f(\text{SAR}_{\text{head}})$ (TEM cell , $f = 900 \text{ MHz}$ )



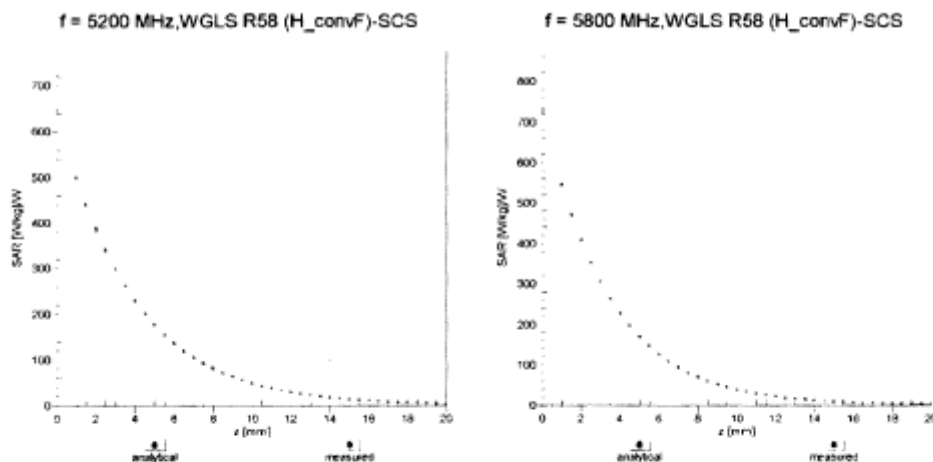
Uncertainty of Linearity Assessment:  $\pm 0.6\%$  ( $k=2$ )

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
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EX3DV4-- SN:3592

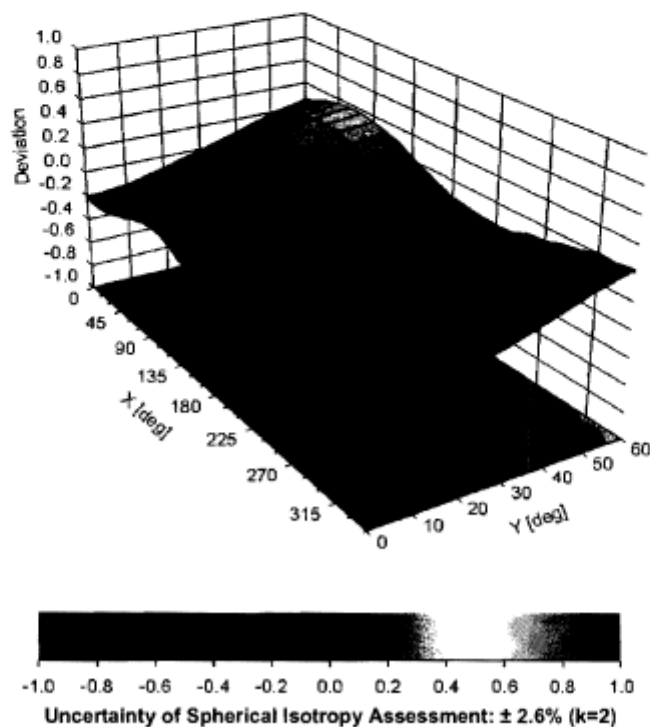
November 16, 2011

## Conversion Factor Assessment



## Deviation from Isotropy in Liquid

Error ( $\phi$ ,  $\theta$ ),  $f = 900 \text{ MHz}$



|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
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EX3DV4– SN:3592

November 16, 2011

## DASY/EASY - Parameters of Probe: EX3DV4 - SN:3592

### Other Probe Parameters

|                                               |                |
|-----------------------------------------------|----------------|
| Sensor Arrangement                            | Triangular     |
| Connector Angle (°)                           | Not applicable |
| Mechanical Surface Detection Mode             | enabled        |
| Optical Surface Detection Mode                | disabled       |
| Probe Overall Length                          | 337 mm         |
| Probe Body Diameter                           | 10 mm          |
| Tip Length                                    | 9 mm           |
| Tip Diameter                                  | 2.5 mm         |
| Probe Tip to Sensor X Calibration Point       | 1 mm           |
| Probe Tip to Sensor Y Calibration Point       | 1 mm           |
| Probe Tip to Sensor Z Calibration Point       | 1 mm           |
| Recommended Measurement Distance from Surface | 2 mm           |

|                                                                                   |                                                                                                              |                                                    |                                            |                                                       |
|-----------------------------------------------------------------------------------|--------------------------------------------------------------------------------------------------------------|----------------------------------------------------|--------------------------------------------|-------------------------------------------------------|
|  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW,<br/>         RFK121LW SAR Report</b> |                                                    |                                            | Page<br><b>30(78)</b>                                 |
|                                                                                   | Author Data<br><b>Andrew Becker</b>                                                                          | Dates of Test<br><b>June 04 – October 29, 2012</b> | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/>         L6ARFK120LW</b> |

**Calibration Laboratory of  
 Schmid & Partner  
 Engineering AG**  
 Zeughausstrasse 43, 8004 Zurich, Switzerland



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**C** Service suisse d'étalonnage  
**S** Servizio svizzero di taratura  
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 The Swiss Accreditation Service is one of the signatories to the EA  
 Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **RIM**

Certificate No: **D750V3-1021\_Jan11**

## CALIBRATION CERTIFICATE

Object **D750V3 - SN: 1021**

Calibration procedure(s) **QA CAL-05.v8  
 Calibration procedure for dipole validation kits**

Calibration date: **January 05, 2011**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&T critical for calibration)

| Primary Standards           | ID #               | Cal Date (Certificate No.)        | Scheduled Calibration  |
|-----------------------------|--------------------|-----------------------------------|------------------------|
| Power meter EPM-442A        | GB37480704         | 06-Oct-10 (No. 217-01266)         | Oct-11                 |
| Power sensor HP 8481A       | US37292783         | 06-Oct-10 (No. 217-01266)         | Oct-11                 |
| Reference 20 dB Attenuator  | SN: 5086 (20g)     | 30-Mar-10 (No. 217-01158)         | Mar-11                 |
| Type-N mismatch combination | SN: 5047.2 / 06327 | 30-Mar-10 (No. 217-01162)         | Mar-11                 |
| Reference Probe ES3DV3      | SN: 3205           | 30-Apr-10 (No. ES3-3205_Apr10)    | Apr-11                 |
| DAE4                        | SN: 601            | 10-Jun-10 (No. DAE4-601_Jun10)    | Jun-11                 |
| Secondary Standards         | ID #               | Check Date (in house)             | Scheduled Check        |
| Power sensor HP 8481A       | MY41092317         | 18-Oct-02 (in house check Oct-09) | in house check: Oct-11 |
| RF generator R&S SMT-06     | 100005             | 4-Aug-99 (in house check Oct-09)  | in house check: Oct-11 |
| Network Analyzer HP 8753E   | US37390585 S4206   | 18-Oct-01 (in house check Oct-10) | in house check: Oct-11 |

|                |                               |                                                                                                            |                                                                                                   |
|----------------|-------------------------------|------------------------------------------------------------------------------------------------------------|---------------------------------------------------------------------------------------------------|
| Calibrated by: | Name<br><b>Jeton Kastrati</b> | Function<br><b>Laboratory Technician</b>                                                                   | Signature<br> |
| Approved by:   | Name<br><b>Katja Pokovic</b>  | Technical Manager<br> |                                                                                                   |

Issued: January 6, 2011

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

|                                                                                   |                                                                                                      |                                            |                                               |                                                   |
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| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                                   | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/> L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW<br/> 2503A-RFK120LW</b> |

|                                                                                   |                                                                                                 |                                            |                                              |                                                  |
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| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW<br/>2503A-RFK120LW</b> |

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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

#### Glossary:

TSL tissue simulating liquid  
ConvF sensitivity in TSL / NORM x,y,z  
N/A not applicable or not measured

#### Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

#### Additional Documentation:

- DASY4/5 System Handbook

#### Methods Applied and Interpretation of Parameters:

- Measurement Conditions:** Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay:** One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured:** SAR measured at the stated antenna input power.
- SAR normalized:** SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters:** The measured TSL parameters are used to calculate the nominal SAR result.

|                                                                                   |                                                                                                 |                                            |                                              |                                                  |
|-----------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------|--------------------------------------------|----------------------------------------------|--------------------------------------------------|
|  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW, RFK121LW SAR Report</b> |                                            |                                              | Page<br><b>33(78)</b>                            |
| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW<br/>2503A-RFK120LW</b> |

### Measurement Conditions

DASY system configuration, as far as not given on page 1.

|                                     |                           |             |
|-------------------------------------|---------------------------|-------------|
| <b>DASY Version</b>                 | DASY5                     | V52.6       |
| <b>Extrapolation</b>                | Advanced Extrapolation    |             |
| <b>Phantom</b>                      | Modular Flat Phantom V4.9 |             |
| <b>Distance Dipole Center - TSL</b> | 15 mm                     | with Spacer |
| <b>Zoom Scan Resolution</b>         | dx, dy, dz = 5 mm         |             |
| <b>Frequency</b>                    | 750 MHz ± 1 MHz           |             |

### Head TSL parameters

The following parameters and calculations were applied.

|                                         | Temperature     | Permittivity | Conductivity     |
|-----------------------------------------|-----------------|--------------|------------------|
| <b>Nominal Head TSL parameters</b>      | 22.0 °C         | 41.9         | 0.89 mho/m       |
| <b>Measured Head TSL parameters</b>     | (22.0 ± 0.2) °C | 42.3 ± 6 %   | 0.91 mho/m ± 6 % |
| <b>Head TSL temperature during test</b> | (22.0 ± 0.2) °C | -----        | -----            |

### SAR result with Head TSL

| <b>SAR averaged over 1 cm<sup>3</sup> (1 g) of Head TSL</b> | Condition          |                                  |
|-------------------------------------------------------------|--------------------|----------------------------------|
| SAR measured                                                | 250 mW input power | 2.12 mW / g                      |
| SAR normalized                                              | normalized to 1W   | 8.48 mW / g                      |
| SAR for nominal Head TSL parameters                         | normalized to 1W   | <b>8.36 mW /g ± 17.0 % (k=2)</b> |

| <b>SAR averaged over 10 cm<sup>3</sup> (10 g) of Head TSL</b> | condition          |                                  |
|---------------------------------------------------------------|--------------------|----------------------------------|
| SAR measured                                                  | 250 mW input power | 1.38 mW / g                      |
| SAR normalized                                                | normalized to 1W   | 5.52 mW / g                      |
| SAR for nominal Head TSL parameters                           | normalized to 1W   | <b>5.45 mW /g ± 16.5 % (k=2)</b> |

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
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|  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW, RFK121LW SAR Report</b> |                                            |                                                    | Page<br><b>34(78)</b>                                  |
| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW</b><br><b>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW</b><br><b>2503A-RFK120LW</b> |

## Appendix

### Antenna Parameters with Head TSL

|                                      |                                 |
|--------------------------------------|---------------------------------|
| Impedance, transformed to feed point | 53.1 $\Omega$ - 1.7 $\mu\Omega$ |
| Return Loss                          | - 29.3 dB                       |

### General Antenna Parameters and Design

|                                  |          |
|----------------------------------|----------|
| Electrical Delay (one direction) | 1.033 ns |
|----------------------------------|----------|

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

### Additional EUT Data

|                 |                   |
|-----------------|-------------------|
| Manufactured by | SPEAG             |
| Manufactured on | December 01, 2010 |

|                                                                                   |                                                                                                      |                                            |                                               |                                                   |
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| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                                   | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/> L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW<br/> 2503A-RFK120LW</b> |

|                                                                                   |                                                                                                 |                                            |                                              |                                                  |
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| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW<br/>2503A-RFK120LW</b> |

## DASY5 Validation Report for Head TSL

Date/Time: 05.01.2011 15:51:17

Test Laboratory: SPEAG, Zurich, Switzerland

**DUT: Dipole 750 MHz; Type: D750V3; Serial: D750V3 - SN:1021**

Communication System: CW; Frequency: 750 MHz; Duty Cycle: 1:1

Medium: HSL750

Medium parameters used:  $f = 750 \text{ MHz}$ ;  $\sigma = 0.91 \text{ mho/m}$ ;  $\epsilon_r = 42.3$ ;  $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

- Probe: ES3DV3 - SN3205; ConvF(6.37, 6.37, 6.37); Calibrated: 30.04.2010
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 10.06.2010
- Phantom: Flat Phantom 4.9L; Type: QD000P49AA; Serial: 1001
- Measurement SW: DASY52, V52.6 Build (401)
- Postprocessing SW: SEMCAD X, V14.4.2 Build (2595)

**Pin=250mW; dip=15mm; dist=3.0mm/Zoom Scan (7x7x7)/Cube 0: Measurement grid:**

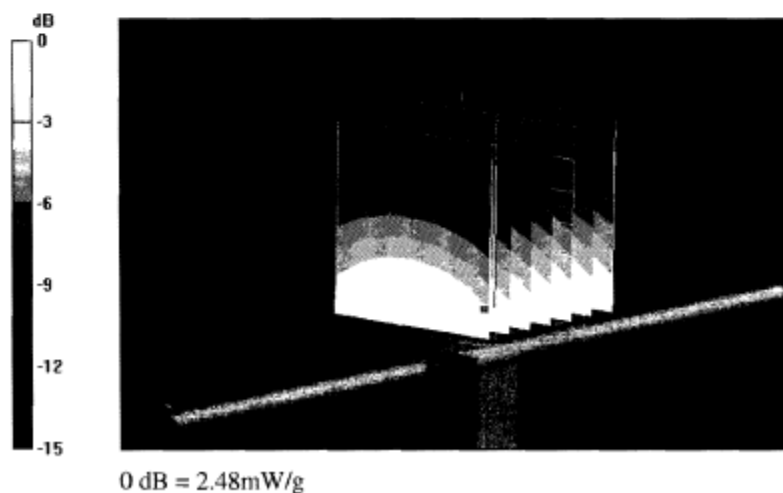
$dx=5\text{mm}$ ,  $dy=5\text{mm}$ ,  $dz=5\text{mm}$

Reference Value = 53.5 V/m; Power Drift = -0.00432 dB

Peak SAR (extrapolated) = 3.24 W/kg

**SAR(1 g) = 2.12 mW/g; SAR(10 g) = 1.38 mW/g**

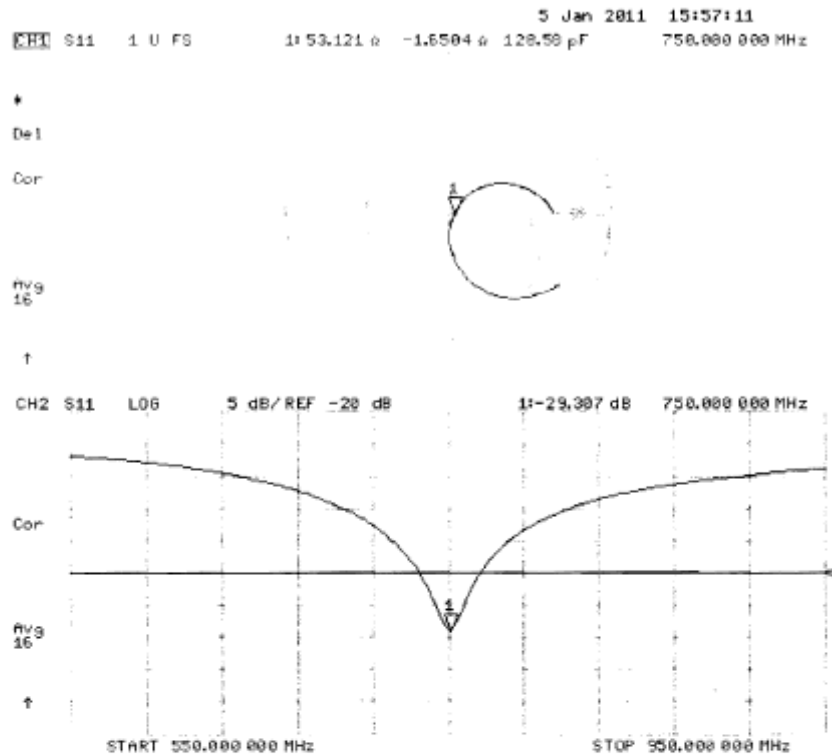
Maximum value of SAR (measured) = 2.48 mW/g



|                                                                                   |                                                                                                      |                                            |                                               |                                                   |
|-----------------------------------------------------------------------------------|------------------------------------------------------------------------------------------------------|--------------------------------------------|-----------------------------------------------|---------------------------------------------------|
|  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW,<br/> RFK121LW SAR Report</b> |                                            |                                               | Page<br><b>37(78)</b>                             |
| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                                   | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/> L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW<br/> 2503A-RFK120LW</b> |

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
|-----------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------|--------------------------------------------|----------------------------------------------------|--------------------------------------------------------|
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| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW</b><br><b>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW</b><br><b>2503A-RFK120LW</b> |

### Impedance Measurement Plot for Head TSL



|                                                                                   |                                                                                                      |                                            |                                               |                                                   |
|-----------------------------------------------------------------------------------|------------------------------------------------------------------------------------------------------|--------------------------------------------|-----------------------------------------------|---------------------------------------------------|
|  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW,<br/> RFK121LW SAR Report</b> |                                            |                                               | Page<br><b>39(78)</b>                             |
| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                                   | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/> L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW<br/> 2503A-RFK120LW</b> |

|                                                                                   |                                                                                                              |                                                    |                                            |                                                       |
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|                                                                                   | Author Data<br><b>Andrew Becker</b>                                                                          | Dates of Test<br><b>June 04 – October 29, 2012</b> | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/>         L6ARFK120LW</b> |

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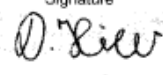
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Accreditation No.: **SCS 108**

Client **RTS (RIM Testing Services)**

Certificate No: **D835V2-446\_Jan11**

## CALIBRATION CERTIFICATE

|                                                                                                                                                                                                                                                                               |                                                                                |                                          |                                                                                                    |
|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------------------------------------------------------------------|------------------------------------------|----------------------------------------------------------------------------------------------------|
| Object                                                                                                                                                                                                                                                                        | <b>D835V2 - SN: 446</b>                                                        |                                          |                                                                                                    |
| Calibration procedure(s)                                                                                                                                                                                                                                                      | <b>QA CAL-05.v8</b><br><b>Calibration procedure for dipole validation kits</b> |                                          |                                                                                                    |
| Calibration date:                                                                                                                                                                                                                                                             | <b>January 21, 2011</b>                                                        |                                          |                                                                                                    |
| This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).<br>The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. |                                                                                |                                          |                                                                                                    |
| All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.                                                                                                                                                |                                                                                |                                          |                                                                                                    |
| Calibration Equipment used (M&TE critical for calibration)                                                                                                                                                                                                                    |                                                                                |                                          |                                                                                                    |
| Primary Standards                                                                                                                                                                                                                                                             | ID #                                                                           | Cal Date (Certificate No.)               | Scheduled Calibration                                                                              |
| Power meter EPM-442A                                                                                                                                                                                                                                                          | GB37480704                                                                     | 06-Oct-10 (No. 217-01266)                | Oct-11                                                                                             |
| Power sensor HP 8481A                                                                                                                                                                                                                                                         | US37292783                                                                     | 06-Oct-10 (No. 217-01266)                | Oct-11                                                                                             |
| Reference 20 dB Attenuator                                                                                                                                                                                                                                                    | SN: 5086 (20g)                                                                 | 30-Mar-10 (No. 217-01158)                | Mar-11                                                                                             |
| Type-N mismatch combination                                                                                                                                                                                                                                                   | SN: 5047.2 / 06327                                                             | 30-Mar-10 (No. 217-01162)                | Mar-11                                                                                             |
| Reference Probe ES3DV3                                                                                                                                                                                                                                                        | SN: 3205                                                                       | 30-Apr-10 (No. ES3-3205_Apr10)           | Apr-11                                                                                             |
| DAE4                                                                                                                                                                                                                                                                          | SN: 601                                                                        | 10-Jun-10 (No. DAE4-601_Jun10)           | Jun-11                                                                                             |
| Secondary Standards                                                                                                                                                                                                                                                           | ID #                                                                           | Check Date (in house)                    | Scheduled Check                                                                                    |
| Power sensor HP 8481A                                                                                                                                                                                                                                                         | MY41092317                                                                     | 18-Oct-02 (in house check Oct-09)        | In house check: Oct-11                                                                             |
| RF generator R&S SMT-06                                                                                                                                                                                                                                                       | 100005                                                                         | 4-Aug-99 (in house check Oct-09)         | In house check: Oct-11                                                                             |
| Network Analyzer HP 8753E                                                                                                                                                                                                                                                     | US37390585 S4206                                                               | 18-Oct-01 (in house check Oct-10)        | In house check: Oct-11                                                                             |
| Calibrated by:                                                                                                                                                                                                                                                                | Name<br><b>Dimce Iliev</b>                                                     | Function<br><b>Laboratory Technician</b> | Signature<br> |
| Approved by:                                                                                                                                                                                                                                                                  | Name<br><b>Katja Pokovic</b>                                                   | Function<br><b>Technical Manager</b>     |               |
| Issued: January 21, 2011<br>This calibration certificate shall not be reproduced except in full without written approval of the laboratory.                                                                                                                                   |                                                                                |                                          |                                                                                                    |

Certificate No: D835V2-446\_Jan11

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|                                                                                   |                                                                                                 |                                            |                                              |                                                  |
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**Glossary:**

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N/A not applicable or not measured

**Calibration is Performed According to the Following Standards:**

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

**Additional Documentation:**

- DASY4/5 System Handbook

**Methods Applied and Interpretation of Parameters:**

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- Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
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|                                                                                   |                                                                                                 |                                            |                                              |                                                  |
|-----------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------|--------------------------------------------|----------------------------------------------|--------------------------------------------------|
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| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW<br/>2503A-RFK120LW</b> |

### Measurement Conditions

DASY system configuration, as far as not given on page 1.

|                                     |                           |             |
|-------------------------------------|---------------------------|-------------|
| <b>DASY Version</b>                 | DASY5                     | V52.6       |
| <b>Extrapolation</b>                | Advanced Extrapolation    |             |
| <b>Phantom</b>                      | Modular Flat Phantom V4.9 |             |
| <b>Distance Dipole Center - TSL</b> | 15 mm                     | with Spacer |
| <b>Zoom Scan Resolution</b>         | dx, dy, dz = 5 mm         |             |
| <b>Frequency</b>                    | 835 MHz ± 1 MHz           |             |

### Head TSL parameters

The following parameters and calculations were applied.

|                                         | Temperature     | Permittivity | Conductivity     |
|-----------------------------------------|-----------------|--------------|------------------|
| <b>Nominal Head TSL parameters</b>      | 22.0 °C         | 41.5         | 0.90 mho/m       |
| <b>Measured Head TSL parameters</b>     | (22.0 ± 0.2) °C | 41.3 ± 6 %   | 0.89 mho/m ± 6 % |
| <b>Head TSL temperature during test</b> | (21.8 ± 0.2) °C | ----         | ----             |

### SAR result with Head TSL

| <b>SAR averaged over 1 cm<sup>3</sup> (1 g) of Head TSL</b> | Condition          |                                  |
|-------------------------------------------------------------|--------------------|----------------------------------|
| SAR measured                                                | 250 mW input power | 2.39 mW / g                      |
| SAR normalized                                              | normalized to 1W   | 9.56 mW / g                      |
| SAR for nominal Head TSL parameters                         | normalized to 1W   | <b>9.63 mW /g ± 17.0 % (k=2)</b> |

| <b>SAR averaged over 10 cm<sup>3</sup> (10 g) of Head TSL</b> | condition          |                                  |
|---------------------------------------------------------------|--------------------|----------------------------------|
| SAR measured                                                  | 250 mW input power | 1.56 mW / g                      |
| SAR normalized                                                | normalized to 1W   | 6.24 mW / g                      |
| SAR for nominal Head TSL parameters                           | normalized to 1W   | <b>6.27 mW /g ± 16.5 % (k=2)</b> |

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
|-----------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------|--------------------------------------------|----------------------------------------------------|--------------------------------------------------------|
|  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW, RFK121LW SAR Report</b> |                                            |                                                    | Page<br><b>43(78)</b>                                  |
| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW</b><br><b>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW</b><br><b>2503A-RFK120LW</b> |

## Appendix

### Antenna Parameters with Head TSL

|                                      |                               |
|--------------------------------------|-------------------------------|
| Impedance, transformed to feed point | 49.6 $\Omega$ - 7.7 $j\Omega$ |
| Return Loss                          | - 22.2 dB                     |

### General Antenna Parameters and Design

|                                  |          |
|----------------------------------|----------|
| Electrical Delay (one direction) | 1.386 ns |
|----------------------------------|----------|

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

### Additional EUT Data

|                 |                  |
|-----------------|------------------|
| Manufactured by | SPEAG            |
| Manufactured on | October 24, 2001 |

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
|-----------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------|--------------------------------------------|----------------------------------------------------|--------------------------------------------------------|
|  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW, RFK121LW SAR Report</b> |                                            |                                                    | Page<br><b>44(78)</b>                                  |
| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW</b><br><b>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW</b><br><b>2503A-RFK120LW</b> |

## DASY5 Validation Report for Head TSL

Date/Time: 21.01.2011 10:18:05

Test Laboratory: SPEAG, Zurich, Switzerland

**DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN:446**

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium: HSL900

Medium parameters used:  $f = 835 \text{ MHz}$ ;  $\sigma = 0.89 \text{ mho/m}$ ;  $\epsilon_r = 41.2$ ;  $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

- Probe: ES3DV3 - SN3205; ConvF(6.03, 6.03, 6.03); Calibrated: 30.04.2010
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 10.06.2010
- Phantom: Flat Phantom 4.9L; Type: QD000P49AA; Serial: 1001
- Measurement SW: DASY52, V52.6.1 Build (408)
- Postprocessing SW: SEMCAD X, V14.4.2 Build (2595)

**Pin=250 mW /d=15mm, dist=3.0mm (ES-Probe)/Zoom Scan (7x7x7) /Cube 0: Measurement**

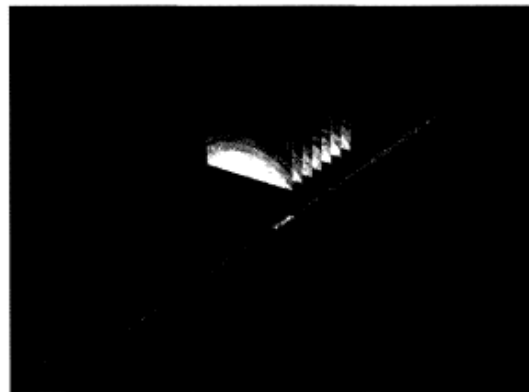
grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 57.426 V/m; Power Drift = 0.04 dB

Peak SAR (extrapolated) = 3.600 W/kg

**SAR(1 g) = 2.39 mW/g; SAR(10 g) = 1.56 mW/g**

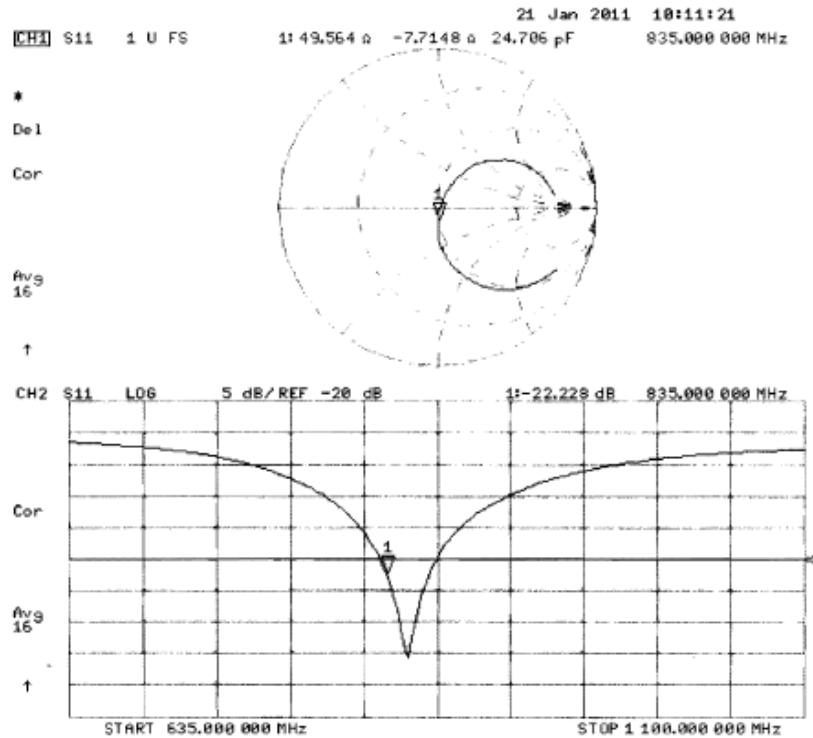
Maximum value of SAR (measured) = 2.790 mW/g



0 dB = 2.790mW/g

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
|-----------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------|--------------------------------------------|----------------------------------------------------|--------------------------------------------------------|
|  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW, RFK121LW SAR Report</b> |                                            |                                                    | Page<br><b>45(78)</b>                                  |
| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW</b><br><b>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW</b><br><b>2503A-RFK120LW</b> |

### Impedance Measurement Plot for Head TSL



|                                                                                  |  |                                                                                                 |                                            |                                                  |
|----------------------------------------------------------------------------------|--|-------------------------------------------------------------------------------------------------|--------------------------------------------|--------------------------------------------------|
|  |  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW, RFK121LW SAR Report</b> |                                            | Page<br><b>46(78)</b>                            |
| Author Data<br><b>Andrew Becker</b>                                              |  | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/>L6ARFK120LW</b>     |
|                                                                                  |  |                                                                                                 |                                            | IC ID<br><b>2503A-RFF90LW<br/>2503A-RFK120LW</b> |

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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **RTS (RIM Testing Services)**

Certificate No: **D1800V2-2d020\_Jan11**

## CALIBRATION CERTIFICATE

Object **D1800V2 - SN: 2d020**

Calibration procedure(s) **QA CAL-05.v8**  
**Calibration procedure for dipole validation kits**

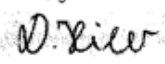
Calibration date: **January 13, 2011**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards           | ID #               | Cal Date (Certificate No.)        | Scheduled Calibration  |
|-----------------------------|--------------------|-----------------------------------|------------------------|
| Power meter EPM-442A        | GB37480704         | 06-Oct-10 (No. 217-01266)         | Oct-11                 |
| Power sensor HP 8481A       | US37292783         | 06-Oct-10 (No. 217-01266)         | Oct-11                 |
| Reference 20 dB Attenuator  | SN: 5086 (20g)     | 30-Mar-10 (No. 217-01158)         | Mar-11                 |
| Type-N mismatch combination | SN: 5047.2 / 06327 | 30-Mar-10 (No. 217-01162)         | Mar-11                 |
| Reference Probe ES3DV3      | SN: 3205           | 30-Apr-10 (No. ES3-3205_Apr10)    | Apr-11                 |
| DAE4                        | SN: 601            | 10-Jun-10 (No. DAE4-601_Jun10)    | Jun-11                 |
| Secondary Standards         | ID #               | Check Date (in house)             | Scheduled Check        |
| Power sensor HP 8481A       | MY41092317         | 18-Oct-02 (in house check Oct-09) | In house check: Oct-11 |
| RF generator R&S SMT-06     | 100005             | 4-Aug-99 (in house check Oct-09)  | In house check: Oct-11 |
| Network Analyzer HP 8753E   | US37390585 S4206   | 18-Oct-01 (in house check Oct-10) | In house check: Oct-11 |

|                |                      |                              |                                                                                       |
|----------------|----------------------|------------------------------|---------------------------------------------------------------------------------------|
|                | Name                 | Function                     | Signature                                                                             |
| Calibrated by: | <b>Dimce Iliev</b>   | <b>Laboratory Technician</b> |  |
| Approved by:   | <b>Katja Pokovic</b> | <b>Technical Manager</b>     |  |

Issued: January 13, 2011

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

|                                                                                  |  |                                                                                                     |                                            |                                                  |
|----------------------------------------------------------------------------------|--|-----------------------------------------------------------------------------------------------------|--------------------------------------------|--------------------------------------------------|
|  |  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW,<br/>RFK121LW SAR Report</b> |                                            | Page<br><b>47(78)</b>                            |
| Author Data<br><b>Andrew Becker</b>                                              |  | Dates of Test<br><b>June 04 – October 29, 2012</b>                                                  | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/>L6ARFK120LW</b>     |
|                                                                                  |  |                                                                                                     |                                            | IC ID<br><b>2503A-RFF90LW<br/>2503A-RFK120LW</b> |

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Accreditation No.: **SCS 108**

#### Glossary:

TSL tissue simulating liquid  
ConvF sensitivity in TSL / NORM x,y,z  
N/A not applicable or not measured

#### Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

#### Additional Documentation:

- DASY4/5 System Handbook

#### Methods Applied and Interpretation of Parameters:

- Measurement Conditions:** Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay:** One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured:** SAR measured at the stated antenna input power.
- SAR normalized:** SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters:** The measured TSL parameters are used to calculate the nominal SAR result.

|                                                                                   |                                                                                                 |                                            |                                              |                                                  |
|-----------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------|--------------------------------------------|----------------------------------------------|--------------------------------------------------|
|  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW, RFK121LW SAR Report</b> |                                            | Page<br><b>48(78)</b>                        |                                                  |
| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW<br/>2503A-RFK120LW</b> |

### Measurement Conditions

DASY system configuration, as far as not given on page 1.

|                                     |                           |             |
|-------------------------------------|---------------------------|-------------|
| <b>DASY Version</b>                 | DASY5                     | V52.6       |
| <b>Extrapolation</b>                | Advanced Extrapolation    |             |
| <b>Phantom</b>                      | Modular Flat Phantom V5.0 |             |
| <b>Distance Dipole Center - TSL</b> | 10 mm                     | with Spacer |
| <b>Zoom Scan Resolution</b>         | dx, dy, dz = 5 mm         |             |
| <b>Frequency</b>                    | 1800 MHz ± 1 MHz          |             |

### Head TSL parameters

The following parameters and calculations were applied.

|                                         | Temperature     | Permittivity | Conductivity     |
|-----------------------------------------|-----------------|--------------|------------------|
| <b>Nominal Head TSL parameters</b>      | 22.0 °C         | 40.0         | 1.40 mho/m       |
| <b>Measured Head TSL parameters</b>     | (22.0 ± 0.2) °C | 38.6 ± 6 %   | 1.38 mho/m ± 6 % |
| <b>Head TSL temperature during test</b> | (21.3 ± 0.2) °C | ----         | ----             |

### SAR result with Head TSL

| <b>SAR averaged over 1 cm<sup>3</sup> (1 g) of Head TSL</b> | Condition          |                                  |
|-------------------------------------------------------------|--------------------|----------------------------------|
| SAR measured                                                | 250 mW input power | 9.78 mW / g                      |
| SAR normalized                                              | normalized to 1W   | 39.1 mW / g                      |
| SAR for nominal Head TSL parameters                         | normalized to 1W   | <b>39.2 mW /g ± 17.0 % (k=2)</b> |

| <b>SAR averaged over 10 cm<sup>3</sup> (10 g) of Head TSL</b> | condition          |                                  |
|---------------------------------------------------------------|--------------------|----------------------------------|
| SAR measured                                                  | 250 mW input power | 5.13 mW / g                      |
| SAR normalized                                                | normalized to 1W   | 20.5 mW / g                      |
| SAR for nominal Head TSL parameters                           | normalized to 1W   | <b>20.5 mW /g ± 16.5 % (k=2)</b> |

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
|-----------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------|--------------------------------------------|----------------------------------------------------|--------------------------------------------------------|
|  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW, RFK121LW SAR Report</b> |                                            |                                                    | Page<br><b>49(78)</b>                                  |
| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW</b><br><b>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW</b><br><b>2503A-RFK120LW</b> |

## Appendix

### Antenna Parameters with Head TSL

|                                      |                                |
|--------------------------------------|--------------------------------|
| Impedance, transformed to feed point | 46.5 $\Omega$ - 7.3 j $\Omega$ |
| Return Loss                          | - 21.5 dB                      |

### General Antenna Parameters and Design

|                                  |          |
|----------------------------------|----------|
| Electrical Delay (one direction) | 1.216 ns |
|----------------------------------|----------|

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

### Additional EUT Data

|                 |                    |
|-----------------|--------------------|
| Manufactured by | SPEAG              |
| Manufactured on | September 07, 2001 |

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
|-----------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------|--------------------------------------------|----------------------------------------------------|--------------------------------------------------------|
|  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW, RFK121LW SAR Report</b> |                                            |                                                    | Page<br><b>50(78)</b>                                  |
| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW</b><br><b>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW</b><br><b>2503A-RFK120LW</b> |

## DASY5 Validation Report for Head TSL

Date/Time: 13.01.2011 12:34:12

Test Laboratory: SPEAG, Zurich, Switzerland

**DUT: Dipole 1800 MHz; Type: D1800V2; Serial: D1800V2 - SN:2d020**

Communication System: CW; Frequency: 1800 MHz; Duty Cycle: 1:1

Medium: HSL U12 BB

Medium parameters used:  $f = 1800 \text{ MHz}$ ;  $\sigma = 1.38 \text{ mho/m}$ ;  $\epsilon_r = 38.7$ ;  $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

- Probe: ES3DV3 - SN3205; ConvF(5.05, 5.05, 5.05); Calibrated: 30.04.2010
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 10.06.2010
- Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001
- Measurement SW: DASY52, V52.6.1 Build (408)
- Postprocessing SW: SEMCAD X, V14.4.2 Build (2595)

**Pin=250 mW /d=10mm, dist=3.0mm (ES-Probe)/Zoom Scan (7x7x7) /Cube 0: Measurement**

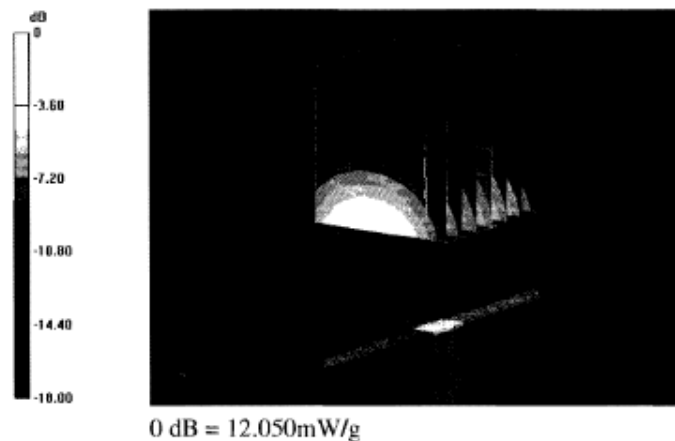
grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 96.654 V/m; Power Drift = 0.04 dB

Peak SAR (extrapolated) = 17.902 W/kg

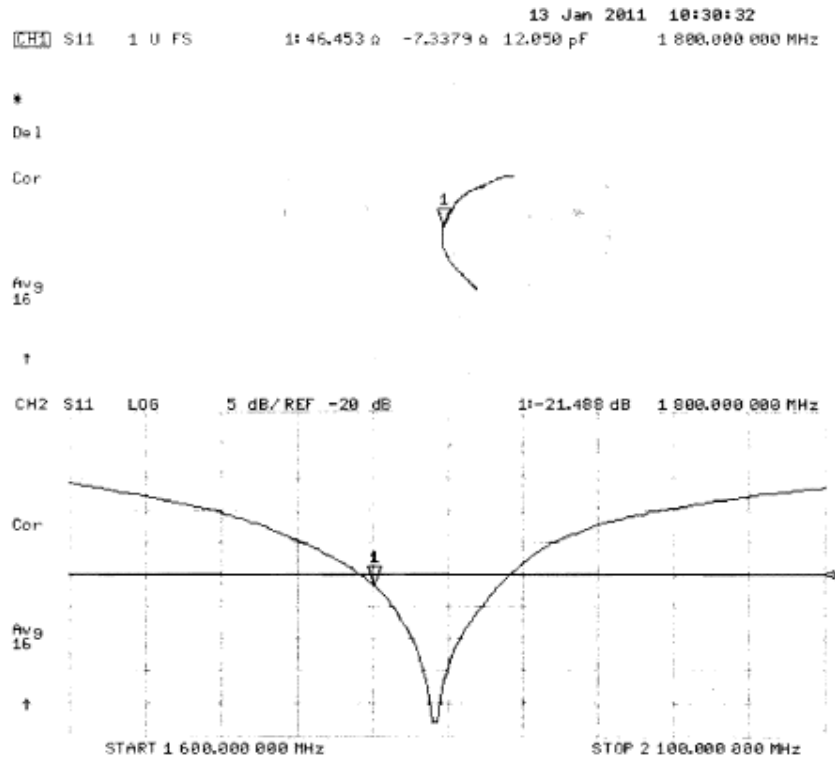
**SAR(1 g) = 9.78 mW/g; SAR(10 g) = 5.13 mW/g**

Maximum value of SAR (measured) = 12.051 mW/g



|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
|-----------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------|--------------------------------------------|----------------------------------------------------|--------------------------------------------------------|
|  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW, RFK121LW SAR Report</b> |                                            |                                                    | Page<br><b>51(78)</b>                                  |
| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW</b><br><b>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW</b><br><b>2503A-RFK120LW</b> |

### Impedance Measurement Plot for Head TSL



|                                                                                   |                                                                                                      |                                            |                                               |                                                   |
|-----------------------------------------------------------------------------------|------------------------------------------------------------------------------------------------------|--------------------------------------------|-----------------------------------------------|---------------------------------------------------|
|  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW,<br/> RFK121LW SAR Report</b> |                                            |                                               | Page<br><b>52(78)</b>                             |
| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                                   | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/> L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW<br/> 2503A-RFK120LW</b> |

|                                                                                   |                                                    |                                                                                                      |                                               |                                                   |
|-----------------------------------------------------------------------------------|----------------------------------------------------|------------------------------------------------------------------------------------------------------|-----------------------------------------------|---------------------------------------------------|
|  |                                                    | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW,<br/> RFK121LW SAR Report</b> |                                               | Page<br><b>53(78)</b>                             |
| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b> | Test Report No<br><b>RTS-6012-1208-35B</b>                                                           | FCC ID:<br><b>L6ARFF90LW<br/> L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW<br/> 2503A-RFK120LW</b> |

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**S** Servizio svizzero di taratura  
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The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **RTS (RIM Testing Services)**

Certificate No: **D1900V2-545\_Jan11**

## CALIBRATION CERTIFICATE

Object **D1900V2 - SN: 545**

Calibration procedure(s) **QA CAL-05.v8  
Calibration procedure for dipole validation kits**

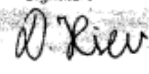
Calibration date: **January 13, 2011**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature ( $22 \pm 3$ )°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards           | ID #               | Cal Date (Certificate No.)        | Scheduled Calibration  |
|-----------------------------|--------------------|-----------------------------------|------------------------|
| Power meter EPM-442A        | GB37480704         | 06-Oct-10 (No. 217-01266)         | Oct-11                 |
| Power sensor HP 8481A       | US37292783         | 06-Oct-10 (No. 217-01266)         | Oct-11                 |
| Reference 20 dB Attenuator  | SN: 5086 (20g)     | 30-Mar-10 (No. 217-01158)         | Mar-11                 |
| Type-N mismatch combination | SN: 5047.2 / 06327 | 30-Mar-10 (No. 217-01162)         | Mar-11                 |
| Reference Probe ES3DV3      | SN: 3205           | 30-Apr-10 (No. ES3-3205_Apr10)    | Apr-11                 |
| DAE4                        | SN: 601            | 10-Jun-10 (No. DAE4-601_Jun10)    | Jun-11                 |
| Secondary Standards         | ID #               | Check Date (in house)             | Scheduled Check        |
| Power sensor HP 8481A       | MY41092317         | 18-Oct-02 (in house check Oct-09) | In house check: Oct-11 |
| RF generator R&S SMT-06     | 100005             | 4-Aug-99 (in house check Oct-09)  | In house check: Oct-11 |
| Network Analyzer HP 8753E   | US37390585 S4206   | 18-Oct-01 (in house check Oct-10) | In house check: Oct-11 |

|                |                              |                                          |                                                                                                    |
|----------------|------------------------------|------------------------------------------|----------------------------------------------------------------------------------------------------|
| Calibrated by: | Name<br><b>Dimitre Iliev</b> | Function<br><b>Laboratory Technician</b> | Signature<br> |
| Approved by:   | Name<br><b>Katja Pokovic</b> | Function<br><b>Technical Manager</b>     | Signature<br> |

Issued: January 14, 2011

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|                                                                                  |  |                                                                                                     |                                            |                                                  |
|----------------------------------------------------------------------------------|--|-----------------------------------------------------------------------------------------------------|--------------------------------------------|--------------------------------------------------|
|  |  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW,<br/>RFK121LW SAR Report</b> |                                            | Page<br><b>54(78)</b>                            |
| Author Data<br><b>Andrew Becker</b>                                              |  | Dates of Test<br><b>June 04 – October 29, 2012</b>                                                  | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/>L6ARFK120LW</b>     |
|                                                                                  |  |                                                                                                     |                                            | IC ID<br><b>2503A-RFF90LW<br/>2503A-RFK120LW</b> |

**Calibration Laboratory of**  
**Schmid & Partner**  
**Engineering AG**  
Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
**C** Service suisse d'étalonnage  
**S** Servizio svizzero di taratura  
**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

#### Glossary:

TSL tissue simulating liquid  
ConvF sensitivity in TSL / NORM x,y,z  
N/A not applicable or not measured

#### Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

#### Additional Documentation:

- DASY4/5 System Handbook

#### Methods Applied and Interpretation of Parameters:

- Measurement Conditions:** Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay:** One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured:** SAR measured at the stated antenna input power.
- SAR normalized:** SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters:** The measured TSL parameters are used to calculate the nominal SAR result.

|                                                                                   |                                                                                                 |                                            |                                              |                                                  |
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|  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW, RFK121LW SAR Report</b> |                                            |                                              | Page<br><b>55(78)</b>                            |
| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW<br/>2503A-RFK120LW</b> |

### Measurement Conditions

DASY system configuration, as far as not given on page 1.

|                                     |                           |             |
|-------------------------------------|---------------------------|-------------|
| <b>DASY Version</b>                 | DASY5                     | V52.6       |
| <b>Extrapolation</b>                | Advanced Extrapolation    |             |
| <b>Phantom</b>                      | Modular Flat Phantom V5.0 |             |
| <b>Distance Dipole Center - TSL</b> | 10 mm                     | with Spacer |
| <b>Zoom Scan Resolution</b>         | dx, dy, dz = 5 mm         |             |
| <b>Frequency</b>                    | 1900 MHz ± 1 MHz          |             |

### Head TSL parameters

The following parameters and calculations were applied.

|                                         | Temperature     | Permittivity | Conductivity     |
|-----------------------------------------|-----------------|--------------|------------------|
| <b>Nominal Head TSL parameters</b>      | 22.0 °C         | 40.0         | 1.40 mho/m       |
| <b>Measured Head TSL parameters</b>     | (22.0 ± 0.2) °C | 38.5 ± 6 %   | 1.43 mho/m ± 6 % |
| <b>Head TSL temperature during test</b> | (21.2 ± 0.2) °C | ----         | ----             |

### SAR result with Head TSL

| <b>SAR averaged over 1 cm<sup>3</sup> (1 g) of Head TSL</b> | Condition          |                                  |
|-------------------------------------------------------------|--------------------|----------------------------------|
| SAR measured                                                | 250 mW input power | 10.2 mW / g                      |
| SAR normalized                                              | normalized to 1W   | 40.8 mW / g                      |
| SAR for nominal Head TSL parameters                         | normalized to 1W   | <b>40.0 mW /g ± 17.0 % (k=2)</b> |

| <b>SAR averaged over 10 cm<sup>3</sup> (10 g) of Head TSL</b> | condition          |                                  |
|---------------------------------------------------------------|--------------------|----------------------------------|
| SAR measured                                                  | 250 mW input power | 5.26 mW / g                      |
| SAR normalized                                                | normalized to 1W   | 21.0 mW / g                      |
| SAR for nominal Head TSL parameters                           | normalized to 1W   | <b>20.8 mW /g ± 16.5 % (k=2)</b> |

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
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|  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW, RFK121LW SAR Report</b> |                                            |                                                    | Page<br><b>56(78)</b>                                  |
| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW</b><br><b>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW</b><br><b>2503A-RFK120LW</b> |

## Appendix

### Antenna Parameters with Head TSL

|                                      |                                |
|--------------------------------------|--------------------------------|
| Impedance, transformed to feed point | 50.8 $\Omega$ + 1.8 j $\Omega$ |
| Return Loss                          | - 34.4 dB                      |

### General Antenna Parameters and Design

|                                  |          |
|----------------------------------|----------|
| Electrical Delay (one direction) | 1.199 ns |
|----------------------------------|----------|

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

### Additional EUT Data

|                 |                   |
|-----------------|-------------------|
| Manufactured by | SPEAG             |
| Manufactured on | November 15, 2001 |

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
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|  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW, RFK121LW SAR Report</b> |                                            |                                                    | Page<br><b>57(78)</b>                                  |
| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW</b><br><b>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW</b><br><b>2503A-RFK120LW</b> |

## DASY5 Validation Report for Head TSL

Date/Time: 13.01.2011 14:52:49

Test Laboratory: SPEAG, Zurich, Switzerland

**DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN:545**

Communication System: CW; Frequency: 1900 MHz; Duty Cycle: 1:1

Medium: HSL U12 BB

Medium parameters used:  $f = 1900 \text{ MHz}$ ;  $\sigma = 1.43 \text{ mho/m}$ ;  $\epsilon_r = 38.6$ ;  $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

- Probe: ES3DV3 - SN3205; ConvF(5.09, 5.09, 5.09); Calibrated: 30.04.2010
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 10.06.2010
- Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001
- Measurement SW: DASY52, V52.6.1 Build (408)
- Postprocessing SW: SEMCAD X, V14.4.2 Build (2595)

**Pin=250 mW /d=10mm, dist=3.0mm (ES-Probe)/Zoom Scan (7x7x7) /Cube 0: Measurement**

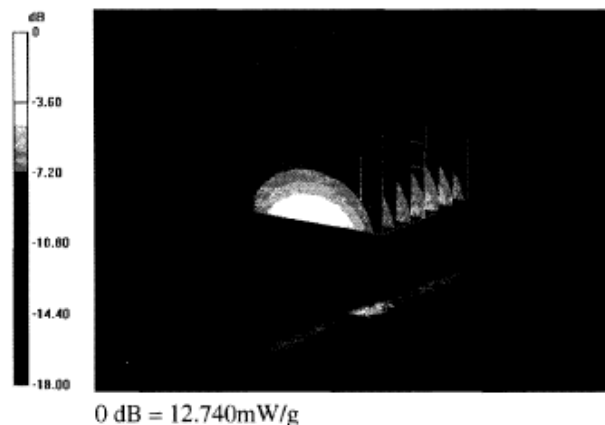
grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 98.053 V/m; Power Drift = 0.03 dB

Peak SAR (extrapolated) = 18.648 W/kg

**SAR(1 g) = 10.2 mW/g; SAR(10 g) = 5.26 mW/g**

Maximum value of SAR (measured) = 12.743 mW/g



Author Data  
**Andrew Becker**

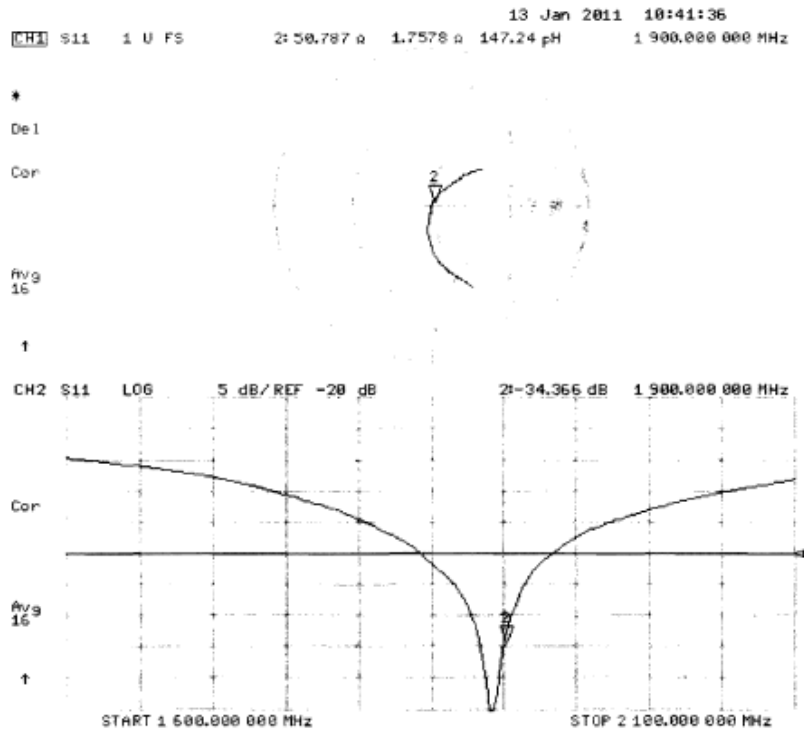
Dates of Test  
**June 04 – October 29, 2012**

Test Report No  
**RTS-6012-1208-35B**

FCC ID:  
**L6ARFF90LW  
L6ARFK120LW**

IC ID  
**2503A-RFF90LW  
2503A-RFK120LW**

### Impedance Measurement Plot for Head TSL



|                                                                                   |                                                                                                              |                                                    |                                            |                                                       |
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|                                                                                   | Author Data<br><b>Andrew Becker</b>                                                                          | Dates of Test<br><b>June 04 – October 29, 2012</b> | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/>         L6ARFK120LW</b> |

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**S** Servizio svizzero di taratura  
**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
 The Swiss Accreditation Service is one of the signatories to the EA  
 Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **RTS (RIM Testing Services)**

Certificate No: **D2450V2-747\_Nov11**

## CALIBRATION CERTIFICATE

Object **D2450V2 - SN: 747**

Calibration procedure(s) **QA CAL-05.v8  
 Calibration procedure for dipole validation kits above 700 MHz**

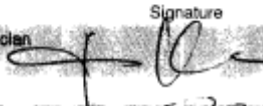
Calibration date: **November 09, 2011**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards           | ID #               | Cal Date (Certificate No.)        | Scheduled Calibration  |
|-----------------------------|--------------------|-----------------------------------|------------------------|
| Power meter EPM-442A        | GB37480704         | 05-Oct-11 (No. 217-01451)         | Oct-12                 |
| Power sensor HP 8481A       | US37292783         | 05-Oct-11 (No. 217-01451)         | Oct-12                 |
| Reference 20 dB Attenuator  | SN: 5086 (20g)     | 29-Mar-11 (No. 217-01368)         | Apr-12                 |
| Type-N mismatch combination | SN: 5047.2 / 06327 | 29-Mar-11 (No. 217-01371)         | Apr-12                 |
| Reference Probe ES3DV3      | SN: 3205           | 29-Apr-11 (No. ES3-3205_Apr11)    | Apr-12                 |
| DAE4                        | SN: 601            | 04-Jul-11 (No. DAE4-601_Jul11)    | Jul-12                 |
| Secondary Standards         | ID #               | Check Date (in house)             | Scheduled Check        |
| Power sensor HP 8481A       | MY41092317         | 18-Oct-02 (in house check Oct-11) | In house check: Oct-13 |
| RF generator R&S SMT-06     | 100005             | 04-Aug-99 (in house check Oct-11) | In house check: Oct-13 |
| Network Analyzer HP 8753E   | US37390585 S4206   | 18-Oct-01 (in house check Oct-11) | In house check: Oct-12 |

|                |                               |                                          |                                                                                                   |
|----------------|-------------------------------|------------------------------------------|---------------------------------------------------------------------------------------------------|
| Calibrated by: | Name<br><b>Jeton Kastrati</b> | Function<br><b>Laboratory Technician</b> | Signature<br> |
| Approved by:   | Name<br><b>Katja Pokovic</b>  | Technical Manager                        |              |

Issued: November 9, 2011

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

|                                                                                   |                                                                                                 |                                            |                                              |                                                  |
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| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW<br/>2503A-RFK120LW</b> |

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**S** Schweizerischer Kalibrierdienst  
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**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

Accreditation No.: **SCS 108**

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

#### Glossary:

TSL tissue simulating liquid  
ConvF sensitivity in TSL / NORM x,y,z  
N/A not applicable or not measured

#### Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

#### Additional Documentation:

- DASY4/5 System Handbook

#### Methods Applied and Interpretation of Parameters:

- Measurement Conditions:** Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay:** One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured:** SAR measured at the stated antenna input power.
- SAR normalized:** SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters:** The measured TSL parameters are used to calculate the nominal SAR result.

|                                                                                   |                                                                                                      |                                            |                                               |                                                   |
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| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                                   | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/> L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW<br/> 2503A-RFK120LW</b> |

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
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| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW</b><br><b>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW</b><br><b>2503A-RFK120LW</b> |

### Measurement Conditions

DASY system configuration, as far as not given on page 1.

|                                     |                        |             |
|-------------------------------------|------------------------|-------------|
| <b>DASY Version</b>                 | DASY5                  | V52.6.2     |
| <b>Extrapolation</b>                | Advanced Extrapolation |             |
| <b>Phantom</b>                      | Modular Flat Phantom   |             |
| <b>Distance Dipole Center - TSL</b> | 10 mm                  | with Spacer |
| <b>Zoom Scan Resolution</b>         | dx, dy, dz = 5 mm      |             |
| <b>Frequency</b>                    | 2450 MHz ± 1 MHz       |             |

### Head TSL parameters

The following parameters and calculations were applied.

|                                                | Temperature     | Permittivity | Conductivity     |
|------------------------------------------------|-----------------|--------------|------------------|
| <b>Nominal Head TSL parameters</b>             | 22.0 °C         | 39.2         | 1.80 mho/m       |
| <b>Measured Head TSL parameters</b>            | (22.0 ± 0.2) °C | 37.7 ± 6 %   | 1.84 mho/m ± 6 % |
| <b>Head TSL temperature change during test</b> | < 0.5 °C        | ----         | ----             |

### SAR result with Head TSL

|                                                               |                    |                                  |
|---------------------------------------------------------------|--------------------|----------------------------------|
| <b>SAR averaged over 1 cm<sup>3</sup> (1 g) of Head TSL</b>   | Condition          |                                  |
| SAR measured                                                  | 250 mW input power | 13.8 mW / g                      |
| SAR for nominal Head TSL parameters                           | normalized to 1W   | <b>54.1 mW /g ± 17.0 % (k=2)</b> |
| <b>SAR averaged over 10 cm<sup>3</sup> (10 g) of Head TSL</b> | condition          |                                  |
| SAR measured                                                  | 250 mW input power | 6.39 mW / g                      |
| SAR for nominal Head TSL parameters                           | normalized to 1W   | <b>25.3 mW /g ± 16.5 % (k=2)</b> |

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
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|  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW, RFK121LW SAR Report</b> |                                            |                                                    | Page<br><b>63(78)</b>                                  |
| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW</b><br><b>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW</b><br><b>2503A-RFK120LW</b> |

## Appendix

### Antenna Parameters with Head TSL

|                                      |                                |
|--------------------------------------|--------------------------------|
| Impedance, transformed to feed point | 52.5 $\Omega$ + 1.3 j $\Omega$ |
| Return Loss                          | - 31.2 dB                      |

### General Antenna Parameters and Design

|                                  |          |
|----------------------------------|----------|
| Electrical Delay (one direction) | 1.161 ns |
|----------------------------------|----------|

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

### Additional EUT Data

|                 |                   |
|-----------------|-------------------|
| Manufactured by | SPEAG             |
| Manufactured on | December 01, 2003 |

|                                                                                   |                                                                                                      |                                            |                                               |                                                   |
|-----------------------------------------------------------------------------------|------------------------------------------------------------------------------------------------------|--------------------------------------------|-----------------------------------------------|---------------------------------------------------|
|  | Document<br><b>Appendix D for the BlackBerry® Smartphone Model RFF91LW,<br/> RFK121LW SAR Report</b> |                                            |                                               | Page<br><b>64(78)</b>                             |
| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                                   | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/> L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW<br/> 2503A-RFK120LW</b> |

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
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| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW</b><br><b>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW</b><br><b>2503A-RFK120LW</b> |

## DASY5 Validation Report for Head TSL

Date: 09.11.2011

Test Laboratory: SPEAG, Zurich, Switzerland

**DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN: 747**

Communication System: CW; Frequency: 2450 MHz

Medium parameters used:  $f = 2450$  MHz;  $\sigma = 1.84$  mho/m;  $\epsilon_r = 37.7$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: ES3DV3 - SN3205; ConvF(4.45, 4.45, 4.45); Calibrated: 29.04.2011
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 04.07.2011
- Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001
- DASY52 52.6.2(482); SEMCAD X 14.4.5(3634)

### Dipole Calibration for Head Tissue/Pin=250 mW, d=10mm/Zoom Scan (7x7x7)/Cube 0:

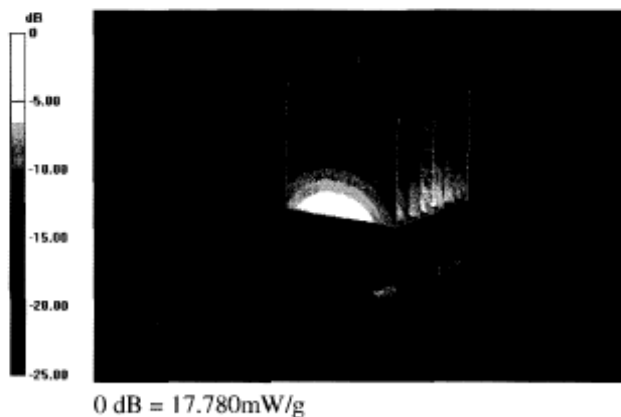
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 102.1 V/m; Power Drift = 0.04 dB

Peak SAR (extrapolated) = 28.853 W/kg

**SAR(1 g) = 13.8 mW/g; SAR(10 g) = 6.39 mW/g**

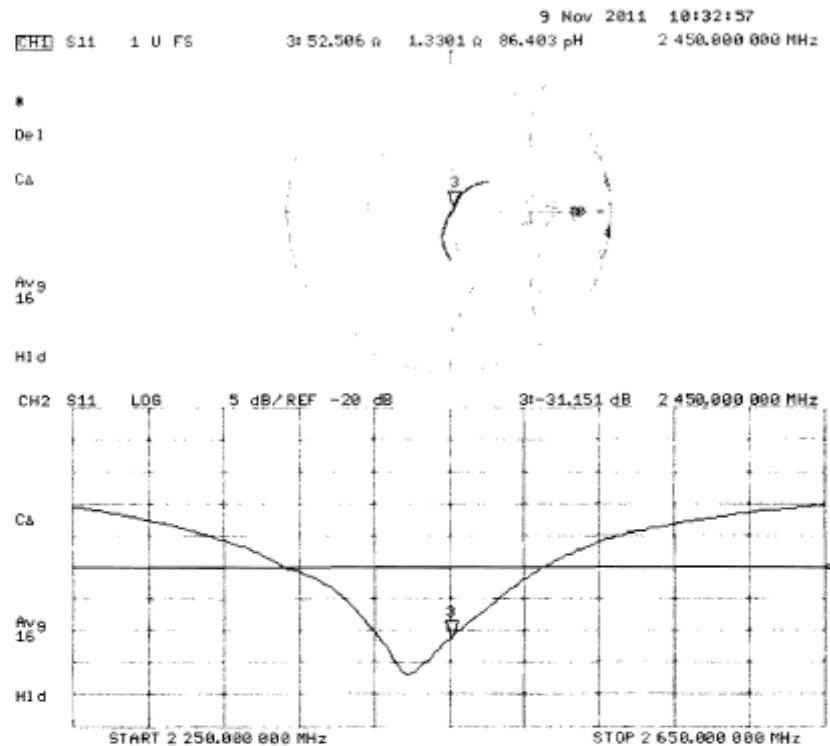
Maximum value of SAR (measured) = 17.782 mW/g



|                                                                                   |                                                                                                      |                                            |                                               |                                                   |
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| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                                   | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW<br/> L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW<br/> 2503A-RFK120LW</b> |

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
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| Author Data<br><b>Andrew Becker</b>                                               | Dates of Test<br><b>June 04 – October 29, 2012</b>                                              | Test Report No<br><b>RTS-6012-1208-35B</b> | FCC ID:<br><b>L6ARFF90LW</b><br><b>L6ARFK120LW</b> | IC ID<br><b>2503A-RFF90LW</b><br><b>2503A-RFK120LW</b> |

# Impedance Measurement Plot for Head TSL



|                                                                                   |                                                                                                      |                                            |                                               |                                                   |
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|                                                                                  |  |                                                                                                     |                                            |                                                  |
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|                                                                                  |  |                                                                                                     |                                            | IC ID<br><b>2503A-RFF90LW<br/>2503A-RFK120LW</b> |

**Calibration Laboratory of  
Schmid & Partner  
Engineering AG**  
Zeughausstrasse 43, 8004 Zurich, Switzerland



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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **RTS (RIM Testing Services)**

Certificate No: **D5GHzV2-1033\_Nov11**

## CALIBRATION CERTIFICATE

Object **D5GHzV2 - SN: 1033**

Calibration procedure(s) **QA CAL-22.v1**  
**Calibration procedure for dipole validation kits between 3-6 GHz**

Calibration date: **November 15, 2011**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards           | ID #               | Cal Date (Certificate No.)        | Scheduled Calibration  |
|-----------------------------|--------------------|-----------------------------------|------------------------|
| Power meter EPM-442A        | GB37480704         | 05-Oct-11 (No. 217-01451)         | Oct-12                 |
| Power sensor HP B481A       | US37292783         | 05-Oct-11 (No. 217-01451)         | Oct-12                 |
| Reference 20 dB Attenuator  | SN: 5086 (20g)     | 29-Mar-11 (No. 217-01368)         | Apr-12                 |
| Type-N mismatch combination | SN: 5047.2 / 06327 | 29-Mar-11 (No. 217-01371)         | Apr-12                 |
| Reference Probe EX3DV4      | SN: 3503           | 04-Mar-11 (No. EX3-3503_Mar11)    | Mar-12                 |
| DAE4                        | SN: 601            | 04-Jul-11 (No. DAE4-601_Jul11)    | Jul-12                 |
| Secondary Standards         | ID #               | Check Date (in house)             | Scheduled Check        |
| Power sensor HP B481A       | MY41092317         | 18-Oct-02 (in house check Oct-11) | In house check: Oct-13 |
| RF generator R&S SMT-06     | 100005             | 04-Aug-99 (in house check Oct-11) | In house check: Oct-13 |
| Network Analyzer HP 8753E   | US37390585 S4206   | 18-Oct-01 (in house check Oct-11) | In house check: Oct-12 |

|                |                              |                                          |                                                                                                    |
|----------------|------------------------------|------------------------------------------|----------------------------------------------------------------------------------------------------|
| Calibrated by: | Name<br><b>Dimce Iliev</b>   | Function<br><b>Laboratory Technician</b> | Signature<br> |
| Approved by:   | Name<br><b>Katja Pokovic</b> | Function<br><b>Technical Manager</b>     | Signature<br> |

Issued: November 16, 2011

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

|                                                                                  |                                                    |                                                                                                     |                                              |                                                  |
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**S** Swiss Calibration Service

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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

#### Glossary:

TSL tissue simulating liquid  
ConvF sensitivity in TSL / NORM x,y,z  
N/A not applicable or not measured

#### Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

#### Additional Documentation:

- DASY4/5 System Handbook

#### Methods Applied and Interpretation of Parameters:

- Measurement Conditions:** Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay:** One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured:** SAR measured at the stated antenna input power.
- SAR normalized:** SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters:** The measured TSL parameters are used to calculate the nominal SAR result.

|                                                                                  |  |                                                                                                     |                                            |                                                  |
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|                                                                                  |  |                                                                                                     |                                            | IC ID<br><b>2503A-RFF90LW<br/>2503A-RFK120LW</b> |

### Measurement Conditions

DASY system configuration, as far as not given on page 1.

|                                     |                                                          |                                  |
|-------------------------------------|----------------------------------------------------------|----------------------------------|
| <b>DASY Version</b>                 | DASY5                                                    | V52.6.2                          |
| <b>Extrapolation</b>                | Advanced Extrapolation                                   |                                  |
| <b>Phantom</b>                      | Modular Flat Phantom V5.0                                |                                  |
| <b>Distance Dipole Center - TSL</b> | 10 mm                                                    | with Spacer                      |
| <b>Zoom Scan Resolution</b>         | dx, dy = 4.0 mm, dz = 1.4 mm                             | Graded Ratio = 1.4 (Z direction) |
| <b>Frequency</b>                    | 5200 MHz ± 1 MHz<br>5500 MHz ± 1 MHz<br>5800 MHz ± 1 MHz |                                  |

### Head TSL parameters at 5200 MHz

The following parameters and calculations were applied.

|                                                | Temperature     | Permittivity | Conductivity     |
|------------------------------------------------|-----------------|--------------|------------------|
| <b>Nominal Head TSL parameters</b>             | 22.0 °C         | 36.0         | 4.66 mho/m       |
| <b>Measured Head TSL parameters</b>            | (22.0 ± 0.2) °C | 34.6 ± 6 %   | 4.46 mho/m ± 6 % |
| <b>Head TSL temperature change during test</b> | < 0.5 °C        | ----         | ----             |

### SAR result with Head TSL at 5200 MHz

|                                                             |                    |                                   |
|-------------------------------------------------------------|--------------------|-----------------------------------|
| <b>SAR averaged over 1 cm<sup>3</sup> (1 g) of Head TSL</b> | Condition          |                                   |
| SAR measured                                                | 100 mW input power | 8.16 mW / g                       |
| SAR for nominal Head TSL parameters                         | normalized to 1W   | <b>80.8 mW / g ± 17.0 % (k=2)</b> |

|                                                               |                    |                                   |
|---------------------------------------------------------------|--------------------|-----------------------------------|
| <b>SAR averaged over 10 cm<sup>3</sup> (10 g) of Head TSL</b> | condition          |                                   |
| SAR measured                                                  | 100 mW input power | 2.33 mW / g                       |
| SAR for nominal Head TSL parameters                           | normalized to 1W   | <b>23.0 mW / g ± 16.5 % (k=2)</b> |

### Head TSL parameters at 5500 MHz

The following parameters and calculations were applied.

|                                                | Temperature     | Permittivity | Conductivity     |
|------------------------------------------------|-----------------|--------------|------------------|
| <b>Nominal Head TSL parameters</b>             | 22.0 °C         | 35.6         | 4.96 mho/m       |
| <b>Measured Head TSL parameters</b>            | (22.0 ± 0.2) °C | 34.2 ± 6 %   | 4.75 mho/m ± 6 % |
| <b>Head TSL temperature change during test</b> | < 0.5 °C        | ----         | ----             |

### SAR result with Head TSL at 5500 MHz

|                                                             |                    |                                   |
|-------------------------------------------------------------|--------------------|-----------------------------------|
| <b>SAR averaged over 1 cm<sup>3</sup> (1 g) of Head TSL</b> | Condition          |                                   |
| SAR measured                                                | 100 mW input power | 8.82 mW / g                       |
| SAR for nominal Head TSL parameters                         | normalized to 1W   | <b>87.3 mW / g ± 17.0 % (k=2)</b> |

|                                                               |                    |                                   |
|---------------------------------------------------------------|--------------------|-----------------------------------|
| <b>SAR averaged over 10 cm<sup>3</sup> (10 g) of Head TSL</b> | condition          |                                   |
| SAR measured                                                  | 100 mW input power | 2.50 mW / g                       |
| SAR for nominal Head TSL parameters                           | normalized to 1W   | <b>24.7 mW / g ± 16.5 % (k=2)</b> |

|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
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#### Head TSL parameters at 5800 MHz

The following parameters and calculations were applied.

|                                         | Temperature     | Permittivity | Conductivity     |
|-----------------------------------------|-----------------|--------------|------------------|
| Nominal Head TSL parameters             | 22.0 °C         | 35.3         | 5.27 mho/m       |
| Measured Head TSL parameters            | (22.0 ± 0.2) °C | 33.7 ± 6 %   | 5.03 mho/m ± 6 % |
| Head TSL temperature change during test | < 0.5 °C        | ----         | ----             |

#### SAR result with Head TSL at 5800 MHz

| SAR averaged over 1 cm <sup>3</sup> (1 g) of Head TSL | Condition          |                                   |
|-------------------------------------------------------|--------------------|-----------------------------------|
| SAR measured                                          | 100 mW input power | 8.03 mW / g                       |
| SAR for nominal Head TSL parameters                   | normalized to 1W   | <b>79.4 mW / g ± 17.0 % (k=2)</b> |

| SAR averaged over 10 cm <sup>3</sup> (10 g) of Head TSL | condition          |                                   |
|---------------------------------------------------------|--------------------|-----------------------------------|
| SAR measured                                            | 100 mW input power | 2.28 mW / g                       |
| SAR for nominal Head TSL parameters                     | normalized to 1W   | <b>22.5 mW / g ± 16.5 % (k=2)</b> |

|                                                                                   |                                                                                                      |                                            |                                               |                                                   |
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|                                                                                   |                                                                                                 |                                            |                                              |                                                  |
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## Appendix

### Antenna Parameters with Head TSL at 5200 MHz

|                                      |                               |
|--------------------------------------|-------------------------------|
| Impedance, transformed to feed point | 51.1 $\Omega$ - 8.7 $j\Omega$ |
| Return Loss                          | - 21.2 dB                     |

### Antenna Parameters with Head TSL at 5500 MHz

|                                      |                               |
|--------------------------------------|-------------------------------|
| Impedance, transformed to feed point | 52.3 $\Omega$ - 2.7 $j\Omega$ |
| Return Loss                          | - 29.2 dB                     |

### Antenna Parameters with Head TSL at 5800 MHz

|                                      |                               |
|--------------------------------------|-------------------------------|
| Impedance, transformed to feed point | 56.7 $\Omega$ - 4.3 $j\Omega$ |
| Return Loss                          | - 22.6 dB                     |

### General Antenna Parameters and Design

|                                  |          |
|----------------------------------|----------|
| Electrical Delay (one direction) | 1.202 ns |
|----------------------------------|----------|

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

### Additional EUT Data

|                 |               |
|-----------------|---------------|
| Manufactured by | SPEAG         |
| Manufactured on | July 09, 2004 |

|                                                                                   |                                                                                                 |                                            |                                              |                                                  |
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## DASY5 Validation Report for Head TSL

Date: 15.11.201

Test Laboratory: SPEAG, Zurich, Switzerland

**DUT: Dipole 5GHz; Type: D5GHzV2; Serial: D5GHzV2 - SN: 1033**

Communication System: CW; Frequency: 5200 MHz, Frequency: 5500 MHz, Frequency: 5800 MHz  
Medium parameters used:  $f = 5200 \text{ MHz}$ ;  $\sigma = 4.46 \text{ mho/m}$ ;  $\epsilon_r = 34.6$ ;  $\rho = 1000 \text{ kg/m}^3$ , Medium parameters used:  $f = 5500 \text{ MHz}$ ;  $\sigma = 4.75 \text{ mho/m}$ ;  $\epsilon_r = 34.2$ ;  $\rho = 1000 \text{ kg/m}^3$ , Medium parameters used:  $f = 5800 \text{ MHz}$ ;  $\sigma = 5.03 \text{ mho/m}$ ;  $\epsilon_r = 33.7$ ;  $\rho = 1000 \text{ kg/m}^3$   
Phantom section: Flat Section  
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: EX3DV4 - SN3503; ConvF(5.41, 5.41, 5.41), ConvF(4.91, 4.91, 4.91), ConvF(4.81, 4.81, 4.81); Calibrated: 04.03.2011
- Sensor-Surface: 1.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 04.07.2011
- Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001
- DASY52 52.6.2(482); SEMCAD X 14.4.5(3634)

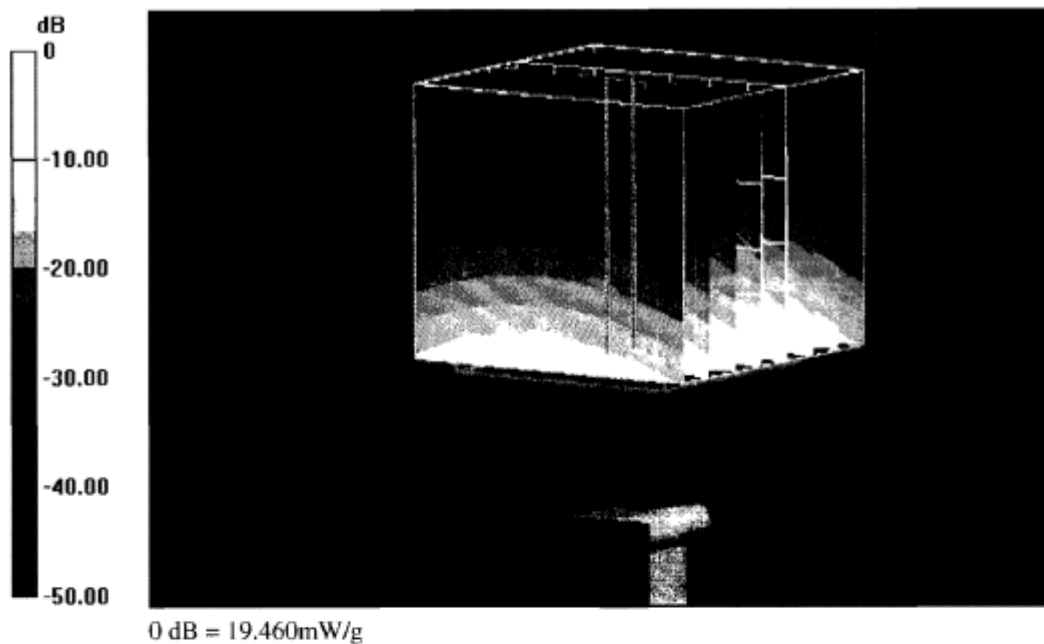
**Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5200 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0:** Measurement grid:  $dx=4\text{mm}$ ,  $dy=4\text{mm}$ ,  $dz=1.4\text{mm}$   
Reference Value = 65.595 V/m; Power Drift = 0.07 dB  
Peak SAR (extrapolated) = 30.134 W/kg  
**SAR(1 g) = 8.16 mW/g; SAR(10 g) = 2.33 mW/g**  
Maximum value of SAR (measured) = 18.725 mW/g

**Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5500 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0:** Measurement grid:  $dx=4\text{mm}$ ,  $dy=4\text{mm}$ ,  $dz=1.4\text{mm}$   
Reference Value = 66.819 V/m; Power Drift = 0.03 dB  
Peak SAR (extrapolated) = 35.056 W/kg  
**SAR(1 g) = 8.82 mW/g; SAR(10 g) = 2.5 mW/g**  
Maximum value of SAR (measured) = 21.019 mW/g

**Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5800 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0:** Measurement grid:  $dx=4\text{mm}$ ,  $dy=4\text{mm}$ ,  $dz=1.4\text{mm}$   
Reference Value = 62.220 V/m; Power Drift = 0.04 dB  
Peak SAR (extrapolated) = 33.743 W/kg  
**SAR(1 g) = 8.03 mW/g; SAR(10 g) = 2.28 mW/g**  
Maximum value of SAR (measured) = 19.463 mW/g

|                                                                                   |                                                                                                      |                                            |                                               |                                                   |
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|                                                                                   |                                                                                                 |                                            |                                                    |                                                        |
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### Impedance Measurement Plot for Head TSL

